Nemko Korea Co., Ltd.

155 & 159, Osan-Ro, Mohyeon-Myeon, Cheoin-Gu, Yongin-Si, Gyeonggi-Do, 449-852 KOREA, REPUBLIC OF
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FCC and IC EVALUATION REPORT FOR CERTIFICATION

Applicant :

Samsung Electronics Co., Ltd.
129, Samsung-ro, Yeongtong-gu,
Suwon-si, Gyeonggi-do, Korea
(Post code : 443-742)
Attn. : Mr. Jaywoo. Lee

Dates of Issue : January 18, 2013
Test Report No. : NK-12-R-241
Test Site : Nemko Korea Co., Ltd.

FCC ID **IC**	**A3LRMCTPF** **649E-RMCTPF**
Brand Name	**SAMSUNG**
Contact Person	**Samsung Electronics Co., Ltd.** **129, Samsung-ro, Yeongtong-gu,** **Suwon-si, Gyeonggi-do, Korea 443-742** **Mr. Jaywoo. Lee** **Telephone No. : +82-31-277-2569**

Applied Standard: FCC 47 CFR Part 15C and IC RSS-210 Issue 8
Classification: FCC Part 15 Spread Spectrum Transmitter (DSS)
EUT Type: Smart Touch Control

The device bearing the brand name and model specified above has been shown to comply with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in ANSI C63.4-2003, ANSI C63.10. The client should not use it to claim product endorsement by TAF or any government agencies. The test results in the report only apply to the tested sample.

I attest to the accuracy of data and all measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

Jan. 18, 2013
Tested By : Jin-ha, Ko
Engineer

Jan 18. 2013
Reviewed By : Deokha Ryu
Manager & Chief Engineer

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1. SCOPE

Measurement and determination of electromagnetic emissions (EME) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission under FCC part 15 subpart C and IC RSS-210 Issue 8.

Responsible Party :	Samsung Electronics Co., Ltd.
Contact Person :	Mr. Jaywoo. Lee
Manufacturer :	Samsung Electronics Co., Ltd. 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, Korea 443-742

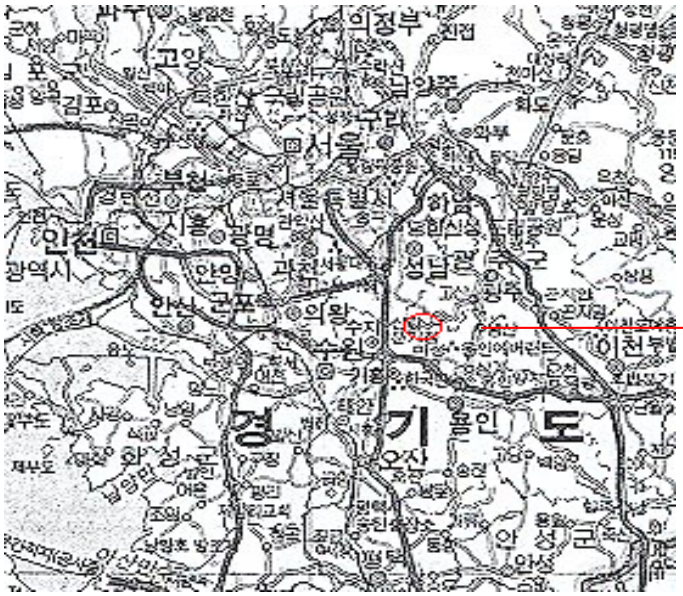
- FCC ID: A3LRMCTPF
- Model: RMCTPF
- Variant Model: RMCTPF1BP1
- Brand Name: SAMSUNG
- EUT Type: Smart Touch Control
- Classification: 15C Intentional Radiator
- Applied Standard: FCC 47 CFR Part 15 subpart C and IC RSS-210 Issue 8
- Test Procedure(s): ANSI C63.4-2003, ANSI C63.10 and FCC Public Notice DA 00-705 dated March 30, 2000 entitled “Filling and Measurement Guidelines for Frequency Hopping Spread Spectrum Systems”
- Dates of Test: December 04, 2012 ~ January 11, 2013
- Place of Tests: Nemko Korea Co., Ltd.

2. INTRODUCTION

2.1 Test facility

The measurement procedure described in American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz (ANSI C63.4-2003), the American National Standard for Testing Unlicensed Wireless Devices (ANSI C63.10-2009) were used in determining radiated and conducted emissions emanating from **Samsung Electronics Co., Ltd.**
FCC ID : A3LRMCTPF and **IC : 649E-RMCTPF**

These measurement tests were conducted at ***Nemko Korea Co., Ltd. EMC Laboratory***.
The site address is 155 & 159, Osan-Ro, Mohyeon-Myeon, Cheoin-Gu, Yongin-Si, Gyeonggi-Do, 449-852 KOREA, REPUBLIC OF.
The area of Nemko Korea Corporation Ltd. EMC Test Site is located in a mountain area at 80 kilo-meters (48 miles) southeast and Incheon International Airport (Incheon Airport), 30 kilometers (18 miles) south-southeast from central Seoul.
It is located in the valley surrounded by mountains in all directions where ambient radio signal conditions are quiet and a favorable area to measure the radio frequency interference on open field test site for the computing and ISM devices manufactures.
The detailed description of the measurement facility was found to be in compliance with the requirements of §2.948 according to ANSI C63.4 2003.



Nemko Korea Co., Ltd.
EMC Lab.

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Fig. 1. The map above shows the Seoul in Korea vicinity area.
The map also shows Nemko Korea Corporation Ltd. EMC Lab. and Incheon Airport.

2.2 Accreditation and listing

Accreditation type		Accreditation number
FC	FCC part 15/18 Filing site	Registration No. 97992
	CAB Accreditation for DOC	Designation No. KR0026
KOLAS	KOLAS Accredited Lab. (Korea Laboratory Accreditation Scheme)	Registration No. 155
Industry Canada	Canada IC Registered site	Site No. 2040E
VCCI	VCCI registration site(RE/CE/Telecom CE)	Member No. 2118
IECEE CB SCHEME	EMC CBTL	-
방송통신위원회	KCC(RRL)Designated Lab.	Registration No. KR0026
	SASO registered Lab and Certification Body	Registration No. 2008-15

3. TEST CONDITIONS & EUT INFORMATION

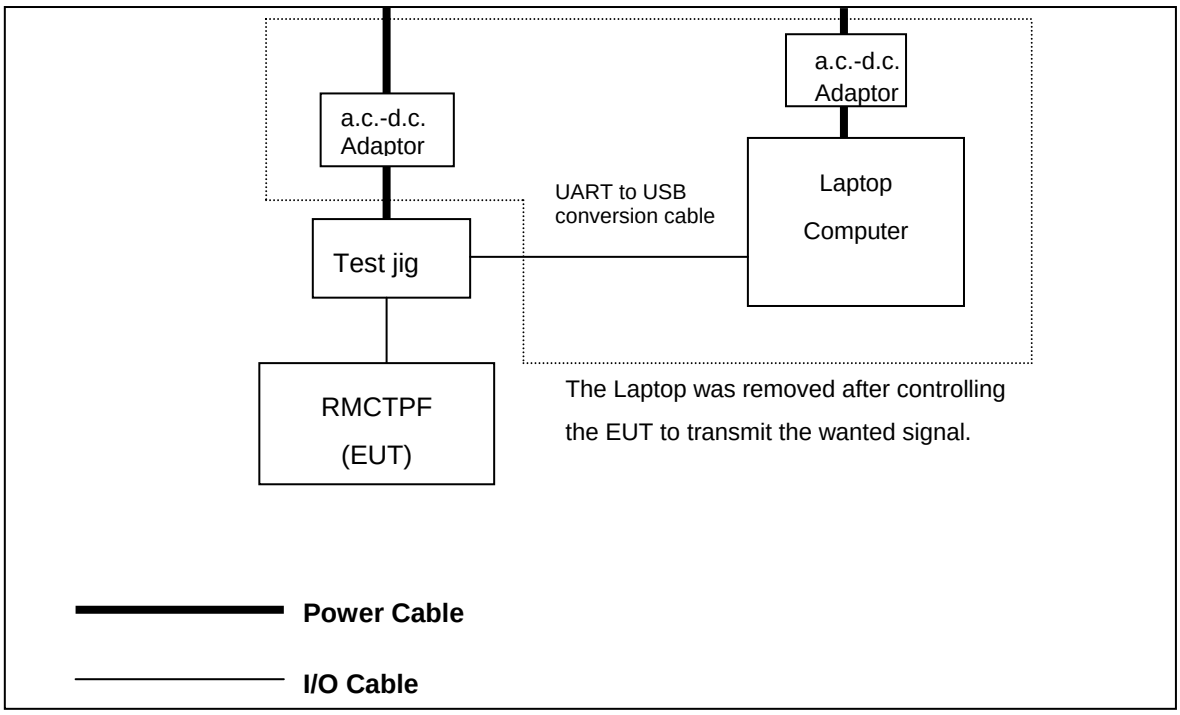
3.1 Operation During Test

The Laptop and Test Jig were used to control the EUT to transmit the wanted TX channel by the Bluetool testing program which manufacturer supported. The Laptop was removed after controlling the EUT to transmit the wanted signal. The EUT was measured in Bluetooth Traffic mode with the maximum output power in accordance with the manufacturer's specifications. For the Maximum Peak output power, Carrier Frequency separation, 20 dB Bandwidth, Band Edge tests were tested with GFSK, π/4DQPSK and 8DPSK modulation. Radiated spurious emissions were measured with 8DPSK modulation mode which was the worst case.

3.2 Support Equipment

Smart Touch Control (EUT)	Samsung Electronics Co., Ltd. Model: RMCTPF Variant Model: RMCTPF1BP1	FCC ID : A3LRMCTPF S/N: N/A
Laptop Computer	Samsung Electronics Co., Ltd. Model : NT-R520 0.4 m shielded UART to USB converter cable	FCC DOC S/N: ZK6V93FS800012Y
AC/DC Adaptor for Laptop	Chicony Power Technology Co., Ltd. Model : AD-6019R 1.5 m unshielded power cable	FCC DOC S/N: CNBA440024ADON897I2602

3.3 Setup Drawing



3.4 EUT Information

The EUT is the **Samsung Smart Touch Control FCC ID: A3LRMCTPF, IC: 649E-RMCTPF.** This unit supports full qualified Bluetooth 3.0 with EDR standard system.

Specifications:

EUT Type	Smart Touch Control
Model Name	RMCTPF
Variant Model Name	RMCTPF1BP1
Brand Name	SAMSUNG
RF Frequency	2402 MHz ~ 2480 MHz
Peak Power Output (Conducted)	GFSK: 0.85 dBm π/4DQPSK: 3.29 dBm 8DPSK: 3.67 dBm
FCC Classification	FCC Part 15 Spread Spectrum Transmitter (DSS)
Method/System	Frequency Hopping Spread Spectrum (FHSS)
Channel Number	79
Modulation	GFSK, π/4DQPSK, 8DPSK
Antenna Gain	3.5 dBi (Peak)
Power	3.0 Vdc (AAA Type Battery)
Size (W x H x D)	49 mm x 19 mm x 134 mm
Weight	147 g (Including battery)

4. SUMMARY OF TEST RESULTS

The EUT has been tested according to the following specification:

Name of Test	FCC Paragraph No.	IC Paragraph No.	Result	Remark
Conducted Emission	15.207	RSS-GEN 7.2.4	Complies	
Radiated Emission	15.209	RSS-210 Issue 8 A8.5	Complies	
20dB Bandwidth and Carrier Frequency Separation	15.247(a)(1)(iii)	RSS-210 Issue 8 A8.1	Complies	
Carrier Frequency Separation	15.247(a)(1)	RSS-210 Issue8 A8.1(2)	Complies	
Transmitter Average Time of Occupancy	15.247(a)(1)(iii)	RSS-210 Issue 8 A8.1(4)	Complies	
Peak Power Output	15.247(b)(1)	RSS-210 Issue 8 A8.4(2)	Complies	
Conducted Spurious Emission	15.247(d)	RSS-210 Issue8 A8.5	Complies	
Radiated Spurious Emission	15.247(d)	RSS-210 Issue8 A8.5	Complies	
Number of Hopping channels	15.247(a)(1)(iii)	RSS-210 Issue 8 A8.1(4)	Complies	

5. RECOMMENDATION/CONCLUSION

The data collected shows that the **Samsung Smart Touch Control FCC ID: A3LRMCTPF, IC: 649E-RMCTPF** is in compliance with Part 15 Subpart C 15.247 of the FCC Rules.

6. ANTENNA REQUIREMENTS

§15.203 of the FCC Rules part 15 Subpart C

: An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section.

The antenna of the **Samsung Smart Touch Control FCC ID: A3LRMCTPF, IC: 649E-RMCTPF** is **permanently attached** and there are no provisions for connection to an external antenna. It complies with the requirement of §15.203.

7. DESCRIPTION OF TESTS

7.1 Conducted Emissions

The Line conducted emission test facility is located inside a 4 x 7 x 2.5 meter shielded enclosure. It is manufactured by EM engineering. The shielding effectiveness of the shielded room is in accordance with MIL-STD-285 or NSA 65-6. A 1 m x 1.5 m wooden table 0.8 m height is placed 0.4 m away from the vertical wall and 1.5 m away from the side of wall of the shielded room Rohde & Schwarz (ESH3-Z5) and (ESH2-Z5) of the 50 ohm/50 μH Line Impedance Stabilization Network (LISN) are bonded to the shielded room. The EUT is powered from the Rohde & Schwarz LISN (ESH3-Z5) and the support equipment is powered from the Rohde & Schwarz LISN (ESH2-Z5). Power to the LISNs are filtered by high-current high insertion loss Power line filters. The purpose of filter is to attenuate ambient signal interference and this filter is also bonded to shielded enclosure. All electrical cables are shielded by tinned copper zipper tubing with inner diameter of 1 / 2 ". If DC power device, power will be derived from the source power supply it normally will be powered from and this supply lines will be connected to the LISNs, All interconnecting cables more than 1 meter were shortened by non inductive bundling (serpentinefashion) to a 1 meter length. Sufficient time for EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The RF output of the LISN was connected to the spectrum analyzer to determine the frequency producing the maximum EME from the EUT. The spectrum was scanned from 150 kHz to 30 MHz with 200 msec sweep time. The frequency producing the maximum level was re-examined using the EMI test receiver. (Rohde & Schwarz ESCS30). The detector functions were set to CISPR quasi-peak mode & average mode. The bandwidth of receiver was set to 9 kHz. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each EME emission. Each emission was maximized by; switching power lines; varying the mode of operation or resolution; clock or data exchange speed; scrolling H pattern to the EUT and of support equipment, and powering the monitor from the floor mounted outlet box and computer aux AC outlet, if applicable; whichever determined the worst case emission.

Each EME reported was calibrated using the R&S signal generator.

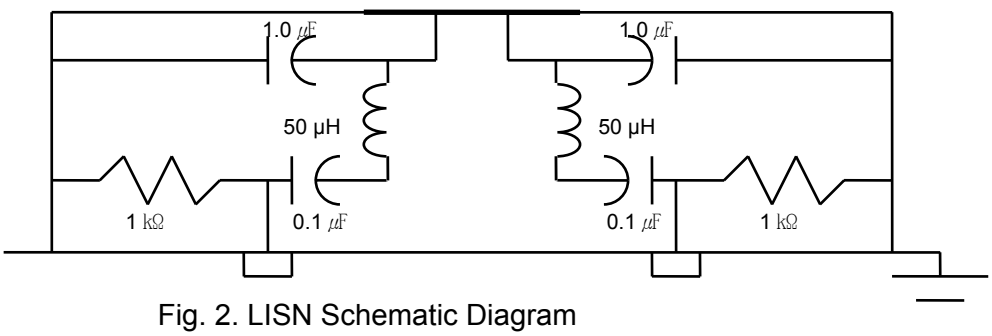


Fig. 2. LISN Schematic Diagram

7.2 Radiated Emissions

The measurement was performed at the test site that is specified in accordance with ANSI C63.4-2003 and ANCI C63.10-2009.

The spurious emission was scanned from 9 kHz to 30 MHz using Loop Antenna(Rohde&Schwarz, HFH2-Z2) and 30 to 1000 MHz using Bi-conical log Antenna(SCHWARZBECK VULB 9168). Above 1 GHz, Horn antenna (Scwarzbeck BBHA 9120D: up to 18 GHz, Q-par Angus QSH20S20 : 18 to 26.5 GHz, QSH22K20: up to 40 GHz) was used.

The test equipment was placed on turntable with 0.8 m above ground. Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The EUT, cable, wire arrangement and mode of operation that has the highest amplitude relative to the limit was selected. Then, the turn table was rotated from 0° to 360° and an antenna mast was moved from 1 m to 4 m height to maximize the suspected highest amplitude signal. The receiver bandwidth was set to 120 kHz for measurements below 1 GHz. For the measurement above 1 GHz, Radiated Peak measurements were taken with RBW set to 1 MHz and VBW was set to 1 MHz with peak detector. Average measurements were taken with RBW 1 MHz and VBW was set to 1 kHz(> 1/ τ Hz where τ is pulse width on second) with peak detector.

Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (meters)
0.009–0.490	2400/F(kHz)	300
0.490–1.705	24000/F(kHz)	30
1.705–30.0	30	30
30–88	100	3
88–216	150	3
216–960	200	3
Above 960	500	3

Radiated Emissions Limits per 47 CFR 15.209(a)

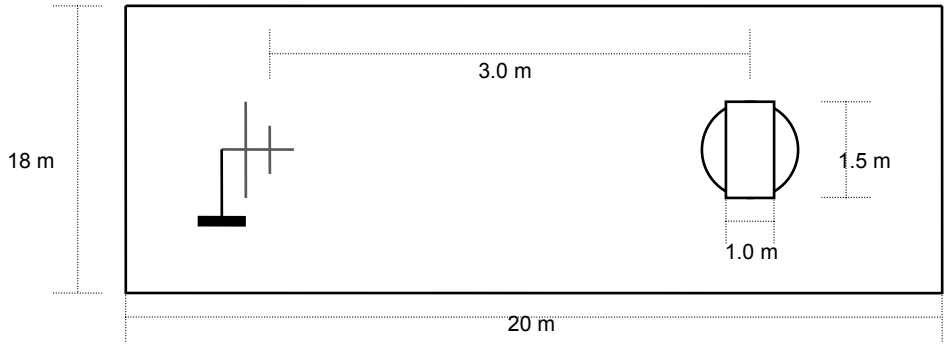
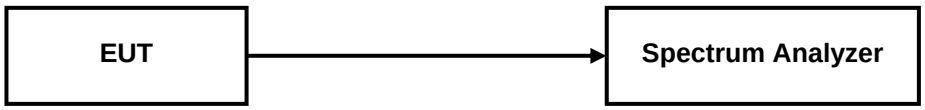


Fig. 3. Dimensions of Outdoor Test Site

7.3 20 dB Bandwidth and Carrier Frequency Separation

Test Setup

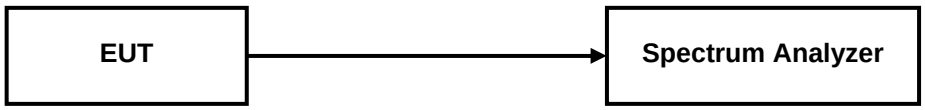


Test Procedure

The transmitter is set to the Low, Middle, High channels is connected to the spectrum analyzer.
Span = approximately 2 to 3 times the 20 dB bandwidth, centered on a hopping channel
RBW ≥ 1% of the 20 dB bandwidth
VBW ≥ RBW
Sweep = auto
Detector function = peak
Trace = max hold

7.4 Transmitter Average Time of Occupancy

Test Setup

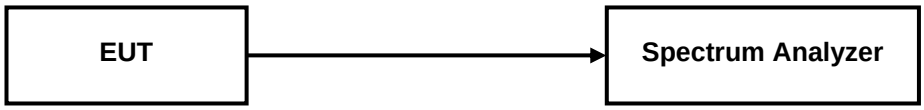


Test Procedure

The transmitter output is connected to a spectrum analyzer. The following spectrum analyzer setting is used.
Span = Zero span, centered on a hopping channel
RBW = 1 MHz, VBW ≥ RBW
Sweep = as necessary to capture the entire dwell time per hopping channel
Detector function = Peak
Trace = Single sweep
Use the marker-delta function to determine the width of pulse

7.5 Number of Hopping Channels

Test Setup

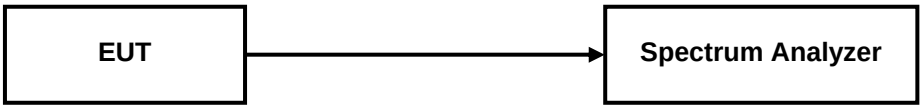


Test Procedure

The transmitter output is connected to a spectrum analyzer. The span is set to cover the entire authorized band, In either a single sweep or in multiple continuous sweeps. The RBW is set to 1 % of the span.
The spectrum analyzer is set to Max Hold.

7.6 Maximum Peak Output Power

Test Setup

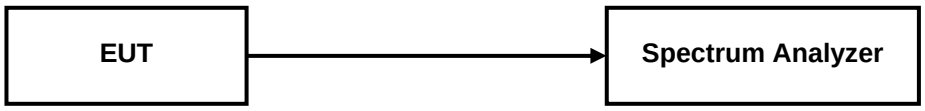


Test Procedure

The transmitter is set to the Low, Middle, High channels is connected to the spectrum analyzer. The RBW of spectrum analyzer is set to 3 MHz and VBW is set to the 3 MHz. The sweep time is coupled.

7.7 Conducted Spurious Emission

Test Setup



Test Procedure

The transmitter is connected to the spectrum analyzer.
The RBW of spectrum analyzer is set to 100 kHz and VBW is set to the 300 kHz.
Measurements are made over the 30 MHz to 25 GHz range with the transmitter set to the Lowest, middle and highest channels.

8. TEST DATA

8.1 Radiated Emissions

FCC §15.209 / IC RSS-210 Issue 8, A8.5

Frequency (MHz)	Reading (dBµV/m)	Pol* (H/V)	Antenna Heights (cm)	Turntable Angles (°)	AF+CL+Amp (dB)**	Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)
31.04	44.33	V	107	148	-18.0	26.3	40.0	13.7
39.30	43.13	V	100	203	-18.0	25.1	40.0	14.9
43.03	44.68	V	102	154	-17.0	27.7	40.0	12.3
250.01	37.10	H	184	276	-15.5	21.6	46.0	24.4
257.78	41.10	H	180	277	-15.5	25.6	46.0	20.4
288.00	40.20	H	145	193	-15.5	24.7	46.0	21.3

Radiated Measurements at 3 meters

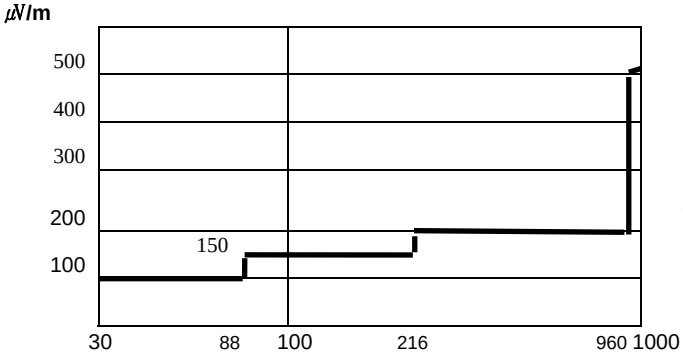


Fig. 4. Limits at 3 meters

NOTES:

1. All modes were measured and the worst-case emission was reported.

2 The radiated limits are shown on Figure 4.

Above 1GHz the limit is 500 µV /m.

*3. *Pol. H = Horizontal V = Vertical*

*4. **AF + CL + Amp. = Antenna Factor + Cable Loss + Amplifier.*

5. Measurements using CISPR quasi-peak mode below 1 GHz.

6. The radiated emissions testing were made by rotating the receive antenna with horizontal, Vertical polarization. The worst date was recorded.

7. The radiated emissions testing were made by rotating EUT through three orthogonal axes and rotating the receive antenna with horizontal, Vertical polarization. The worst date was recorded.

8.2 20 dB Modulated Bandwidth

FCC §15.247(a)(1)(iii) / IC RSS-210 Issue 8, A8.1

Test Mode : Set to Lowest channel, Middle channel and Highest channel

Result:

Modulation Mode	Frequency(MHz)	Result(kHz)	Limit(kHz)
GFSK	2402	933.2	Non specified
GFSK	2441	933.5	Non specified
GFSK	2480	935.1	Non specified
π/4DQPSK	2402	1350.0	Non specified
π/4DQPSK	2441	1348.0	Non specified
π/4DQPSK	2480	1345.0	Non specified
8DPSK	2402	1350.0	Non specified
8DPSK	2441	1349.0	Non specified
8DPSK	2480	1345.0	Non specified

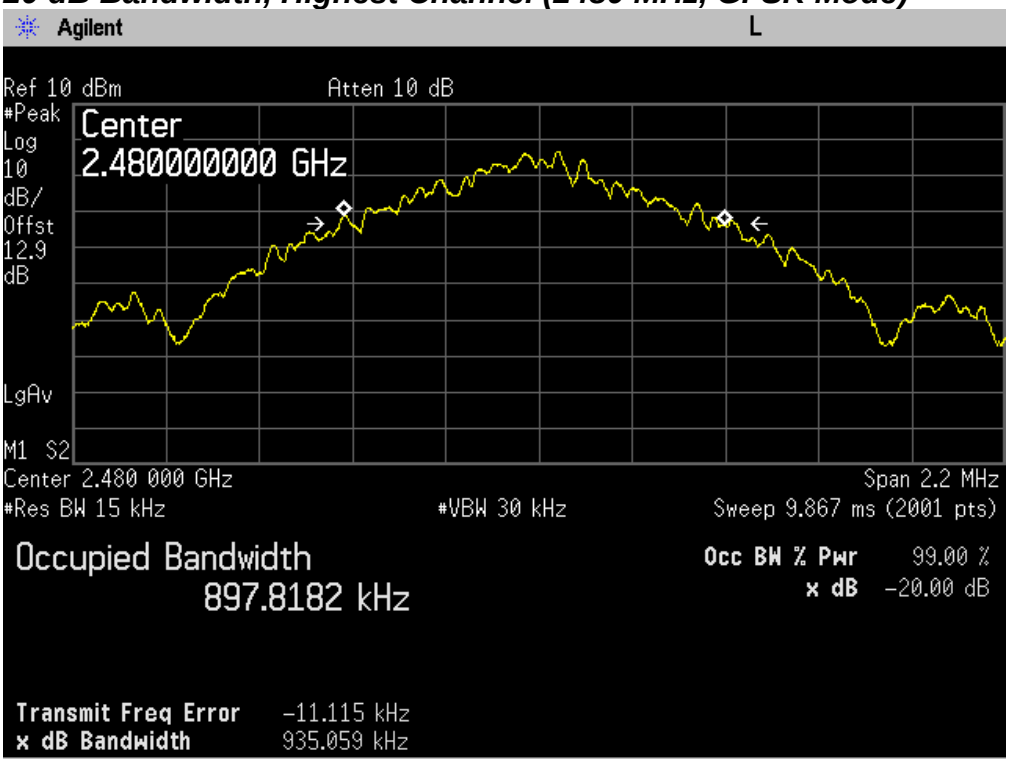
PLOTS OF EMISSIONS

20 dB Bandwidth, Lowest Channel (2402 MHz, GFSK Mode)

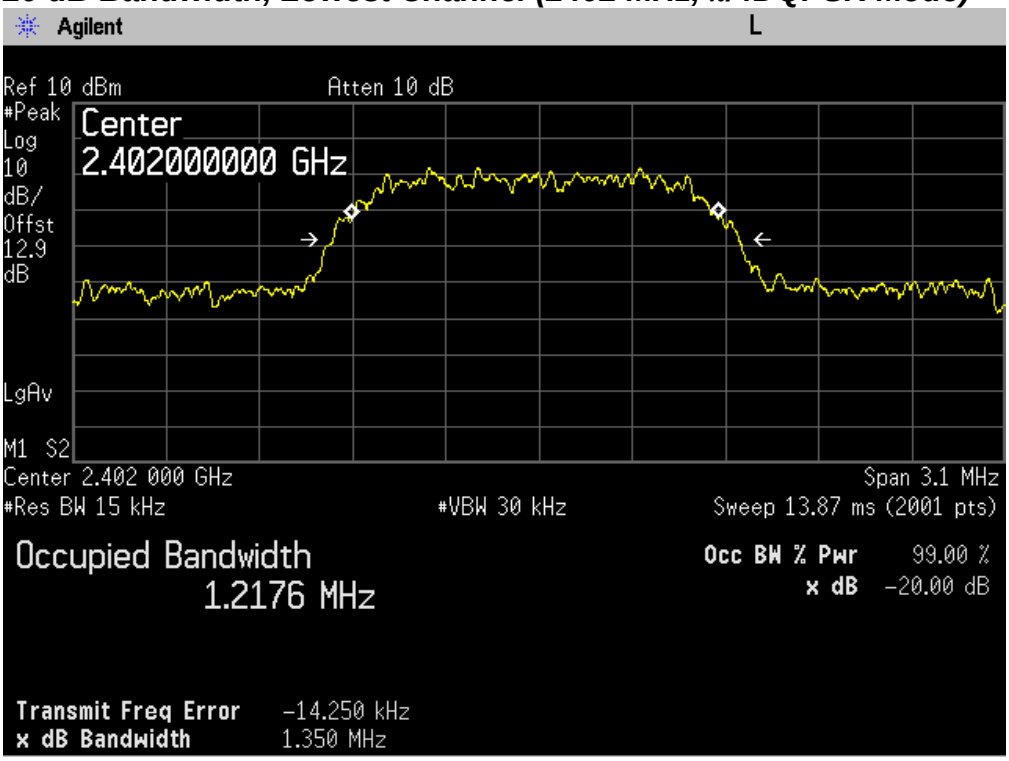
20 dB Bandwidth, Middle Channel (2441 MHz, GFSK Mode)

PLOTS OF EMISSIONS

20 dB Bandwidth, Highest Channel (2480 MHz, GFSK Mode)

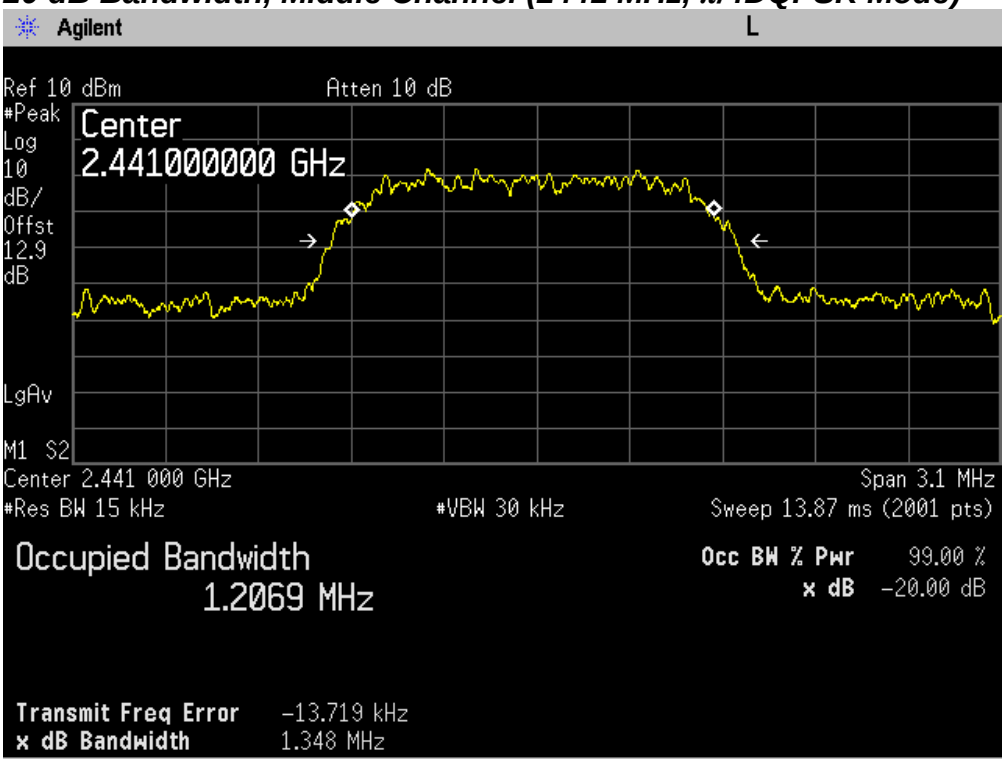


20 dB Bandwidth, Lowest Channel (2402 MHz, π/4DQPSK Mode)

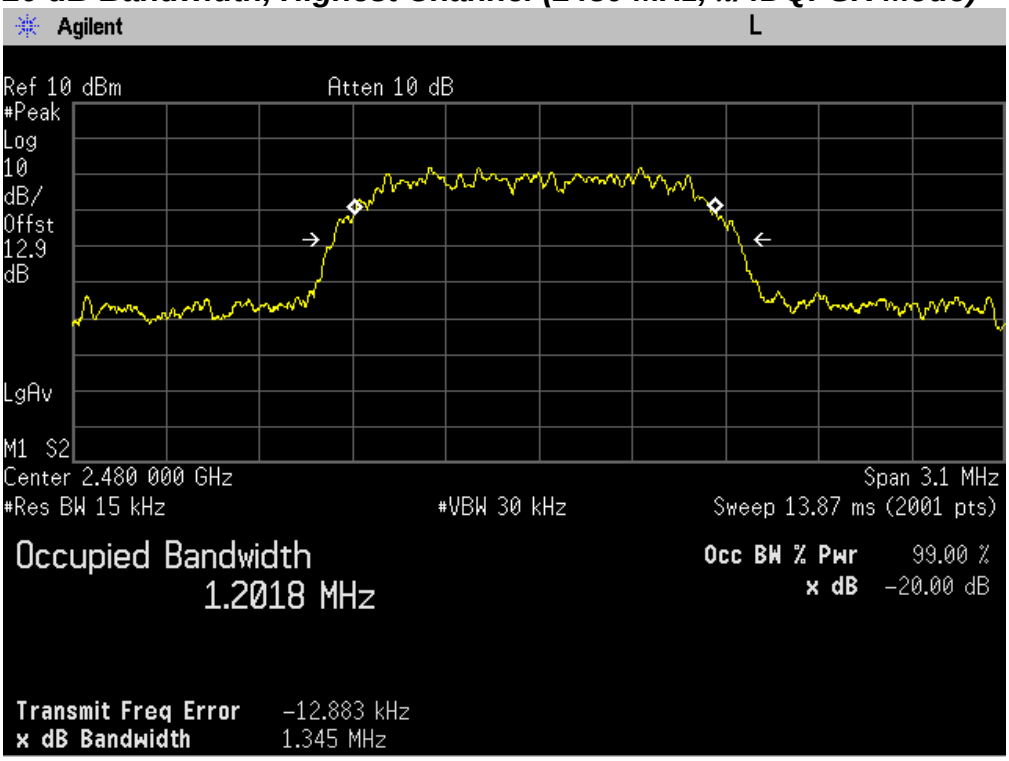


PLOTS OF EMISSIONS

20 dB Bandwidth, Middle Channel (2441 MHz, π/4DQPSK Mode)

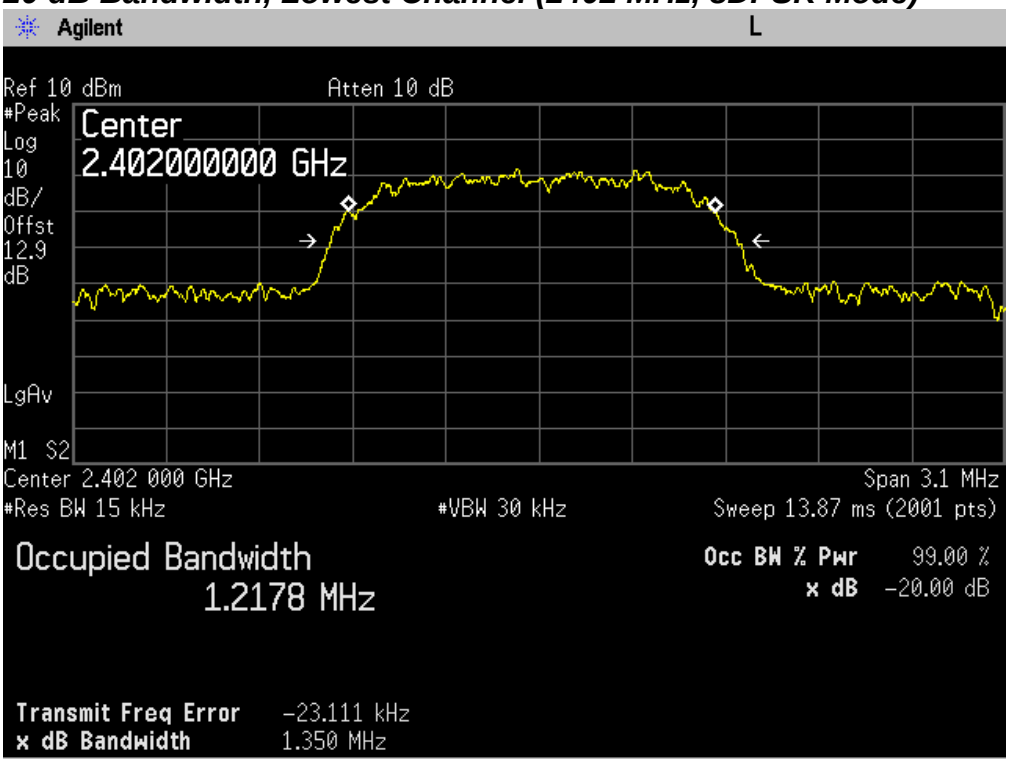


20 dB Bandwidth, Highest Channel (2480 MHz, π/4DQPSK Mode)

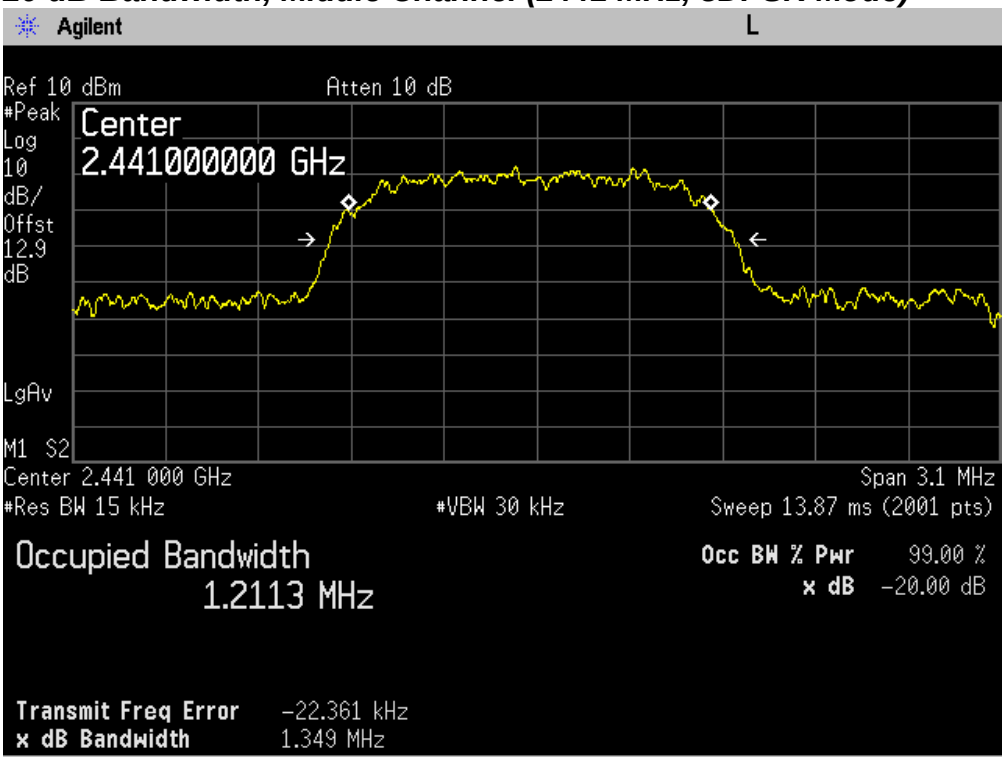


PLOTS OF EMISSIONS

20 dB Bandwidth, Lowest Channel (2402 MHz, 8DPSK Mode)

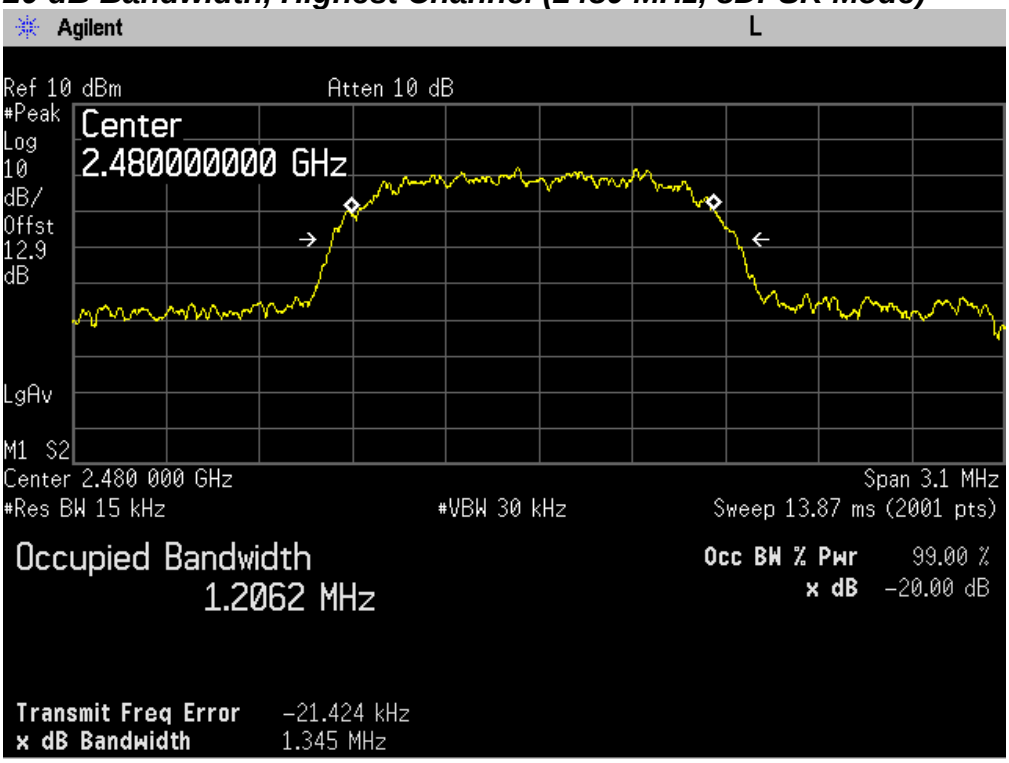


20 dB Bandwidth, Middle Channel (2441 MHz, 8DPSK Mode)



PLOTS OF EMISSIONS

20 dB Bandwidth, Highest Channel (2480 MHz, 8DPSK Mode)



8.3 Carrier Frequency Separation

FCC §15.247(a)(1) / IC RSS-210 Issue 8, A8.1(2)

Test Mode : Set to Hopping mode

Result:

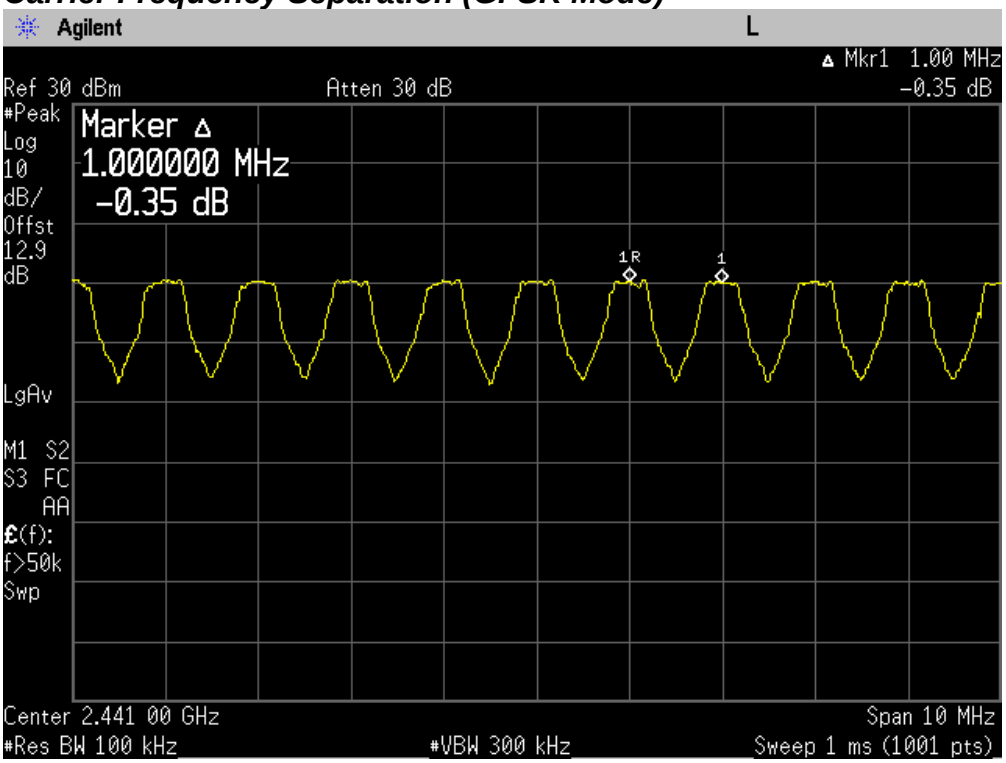
Modulation Mode	Carrier Frequency Separation (kHz)	Limit (2 / 3 of 20dB Bandwidth) (kHz)	Margin (kHz)
GFSK	1000	923.4	376.6
π/4DQPSK	1000	900.0	100.0
8DPSK	1000	900.0	100.0

Note:

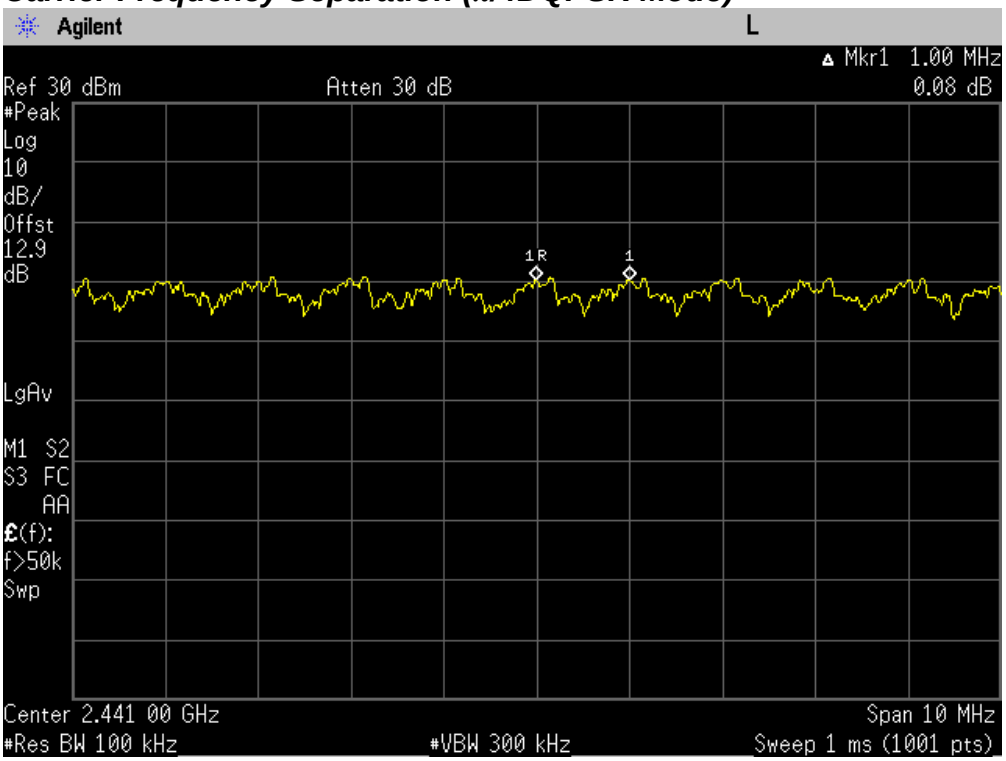
*The EUT complies with the minimum channel separation requirement when it is operating **1x/EDR mode using 79 channels** and when operating in **AFH mode using 20 channels**.*

PLOTS OF EMISSIONS

Carrier Frequency Separation (GFSK Mode)

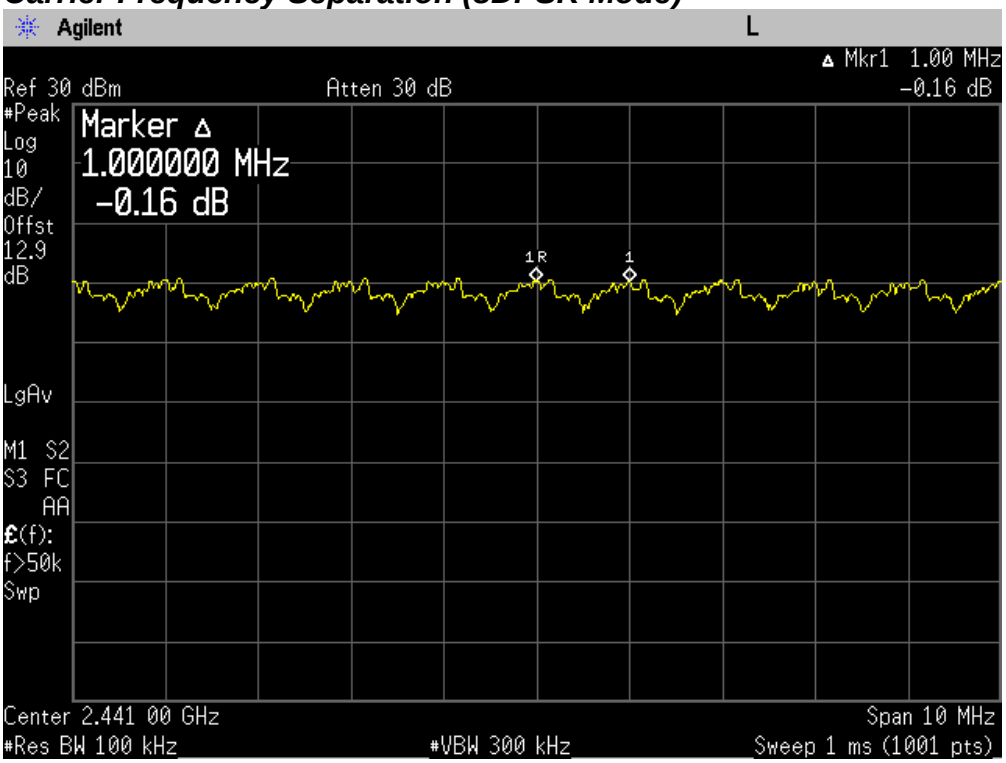


Carrier Frequency Separation (π/4DQPSK Mode)



PLOTS OF EMISSIONS

Carrier Frequency Separation (8DPSK Mode)



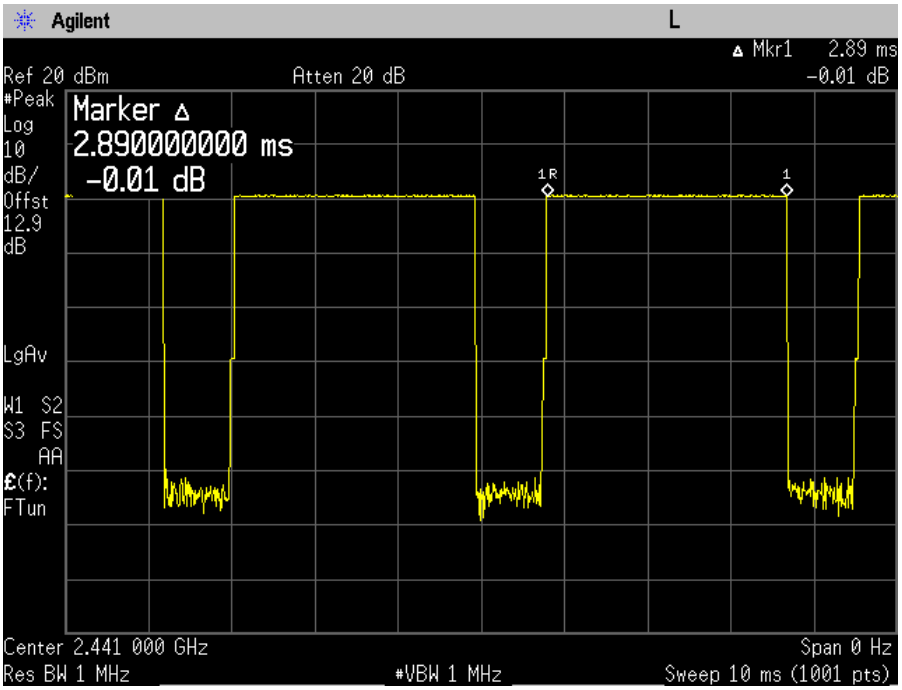
8.4 Transmitter Average Time of Occupancy

FCC §15.247(a)(1)(iii) / IC RSS-210 Issue 8, A8.1(4)

Test mode : Set to Hopping mode

Result:

Mode	Pulse width (ms)	*)Numbers of slots	**) Average time of Occupancy(ms)	Limit (ms)	Margin (ms)
1x/EDR	2.89	106.7	308.4	≤400	91.6
AFH	2.89	53.3	154.1	≤400	245.9



1x/EDR mode

1) This result was measured at DH5 mode in **1x/EDR mode**, which has longest time in one transmission burst.
2) Bluetooth 1x/EDR mode has a channel hopping rate of 1600 hops/s and 79 hopping channels.
3) The average time of occupancy in the specified 31.6 second period (79 channels x 0.4 s) is equal to pulse width x (hopping rate / 6) / 79 x (0.4 x hopping channels).

4) *) Numbers of slots in 31.6 sec = (1600 / 6) / 79 x 31.6

5) **) Average time of Occupancy = 2.89 ms x 106.7 = 308.4 ms

AFH mode

1) This result was measured at DH5 mode in **AFH mode**, which has longest time in one transmission burst.
2) Bluetooth AFH mode has a channel hopping rate of 800 hops/s and 20 hopping channels.
3) The average time of occupancy in the specified 8 second period (20 channels x 0.4 s) is equal to pulse width x (hopping rate / 6) / 20 x (0.4 x hopping channels).
4) *) Numbers of slots in 20 sec = (800 / 6) / 20 x 8
5) **) Average time of Occupancy = 2.89 ms x 53.33 = 154.1 ms

8.5 Number of Hopping Channels

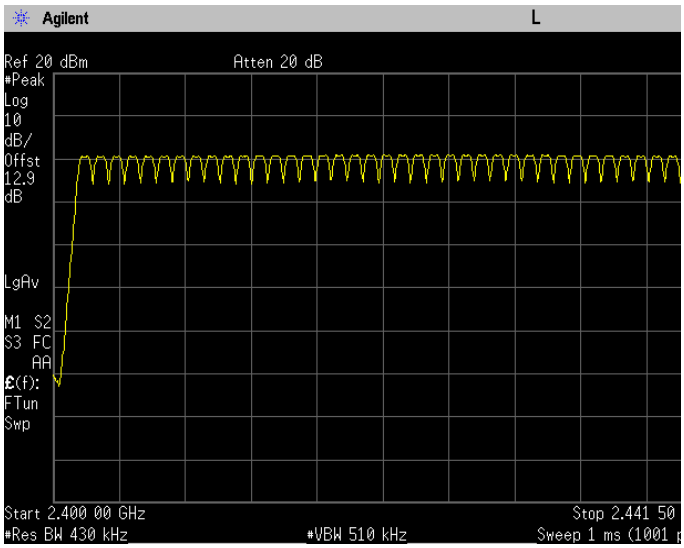
FCC §15.247(a)(1)(iii) / IC RSS-210 Issue 8, A8.1(4)

Test mode : Set to Hopping mode

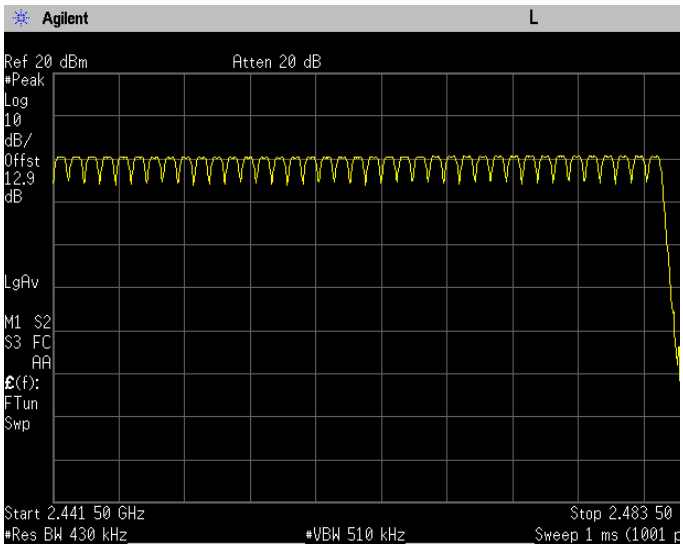
Result:

The EUT complies with the minimum number of hopping channels when it is operating **1x/EDR mode using 79 channels** and when operating in **AFH mode using 20 channels**.

Top half of Authorized band(1x mode)



Bottom half of Authorized band(1x mode)



8.6 Peak Power Output

FCC §15.247(b)(1) / IC RSS-210 Issue 8, A8.4(2)

Test Mode : Set to Lowest channel, Middle channel and Highest channel

Result:

Modulation	Frequency (MHz)	Peak Power (dBm)	Limit (dBm)	Margin (dB)
GFSK	2402	0.79	30.00	29.21
GFSK	2441	0.78	30.00	29.22
GFSK	2480	0.85	30.00	29.15
π/4DQPSK	2402	2.79	30.00	27.21
π/4DQPSK	2441	3.03	30.00	26.97
π/4DQPSK	2480	3.29	30.00	26.71
8DPSK	2402	3.13	30.00	26.87
8DPSK	2441	3.38	30.00	26.62
8DPSK	2480	3.67	30.00	26.33

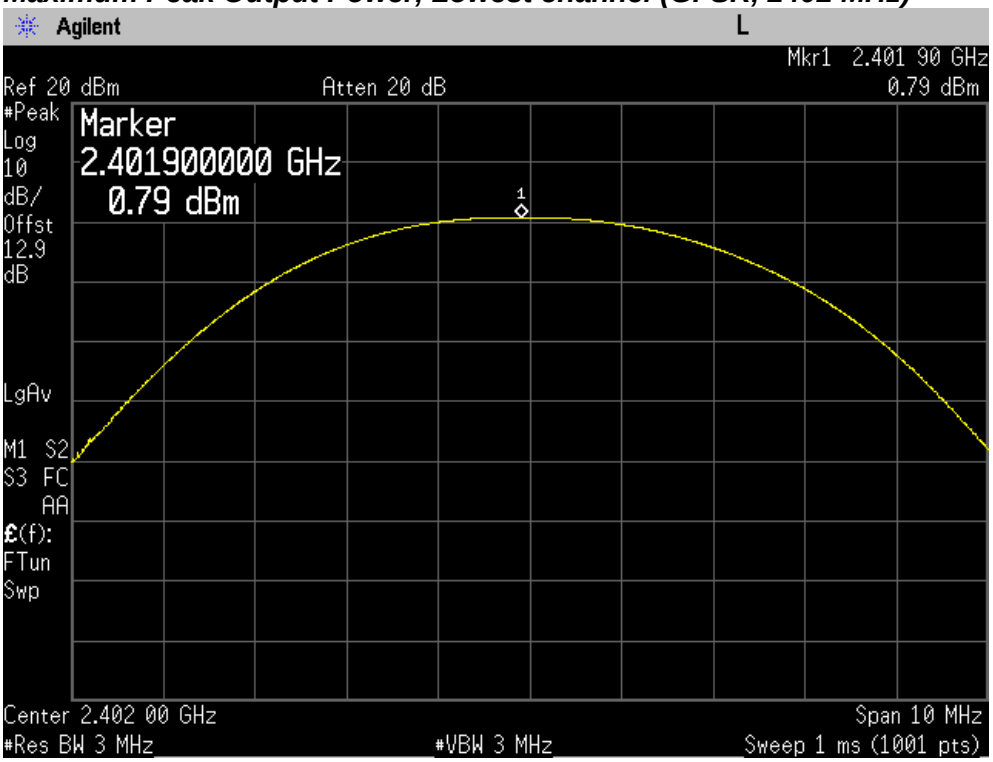
Note:

The following formular was used for spectrum offset:

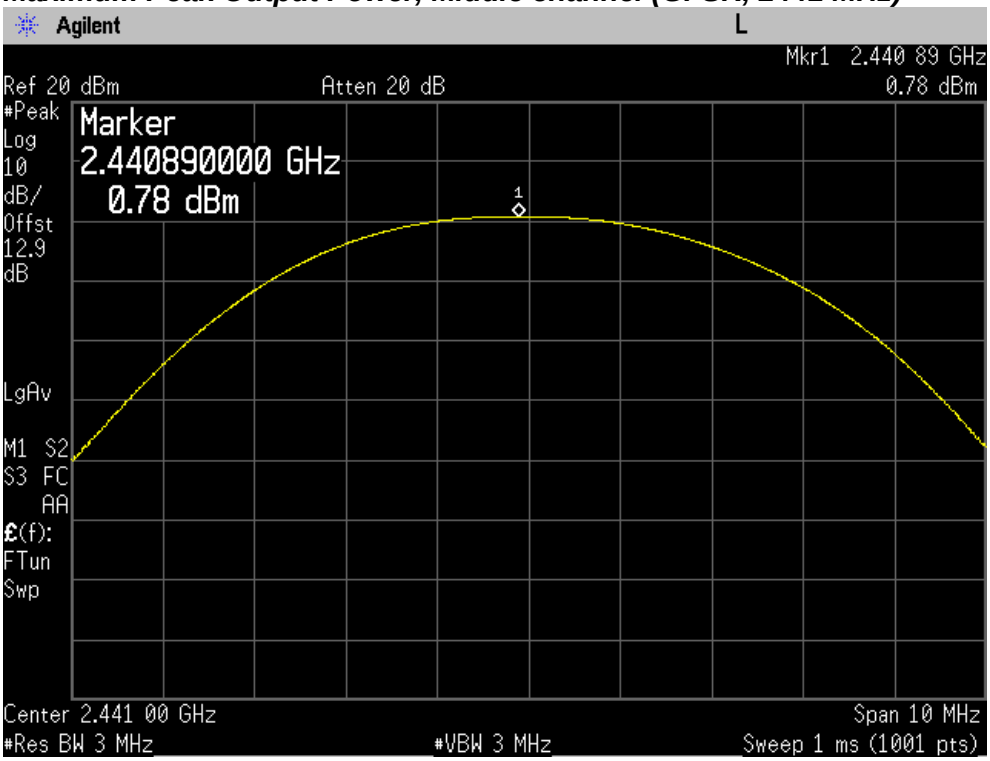
Spectrum offset (dB) = Attenuator (dB) + Cable Loss (dB) + SMA Type Connector Loss (dB)

PLOT OF TEST DATA

Maximum Peak Output Power, Lowest channel (GFSK, 2402 MHz)

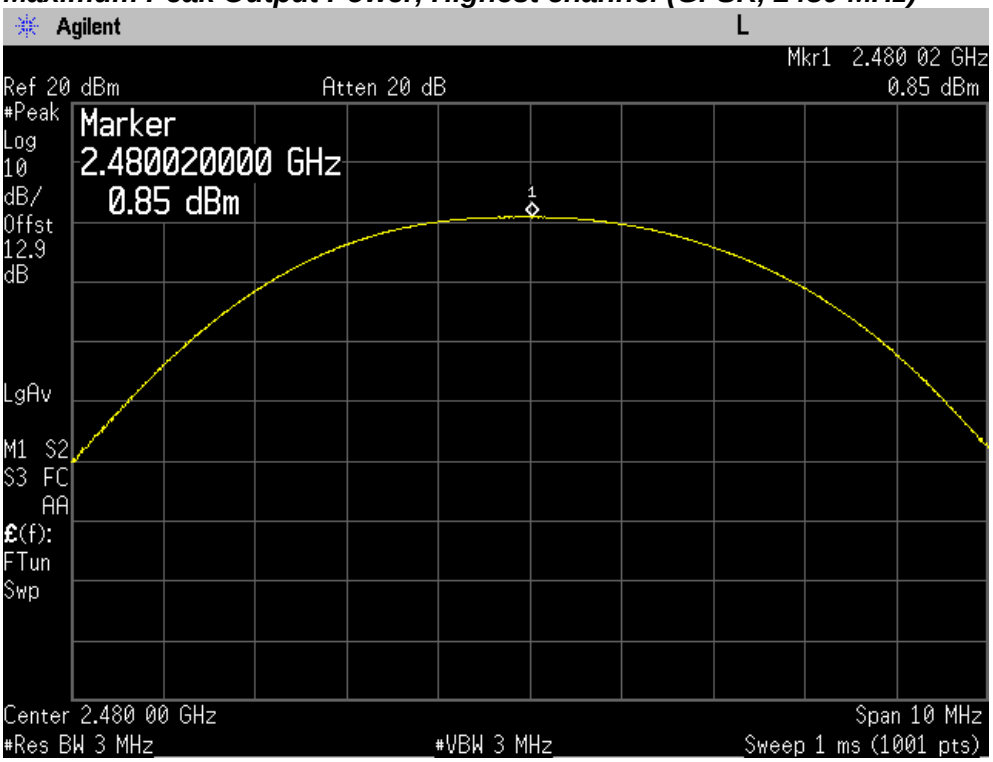


Maximum Peak Output Power, Middle channel (GFSK, 2441 MHz)

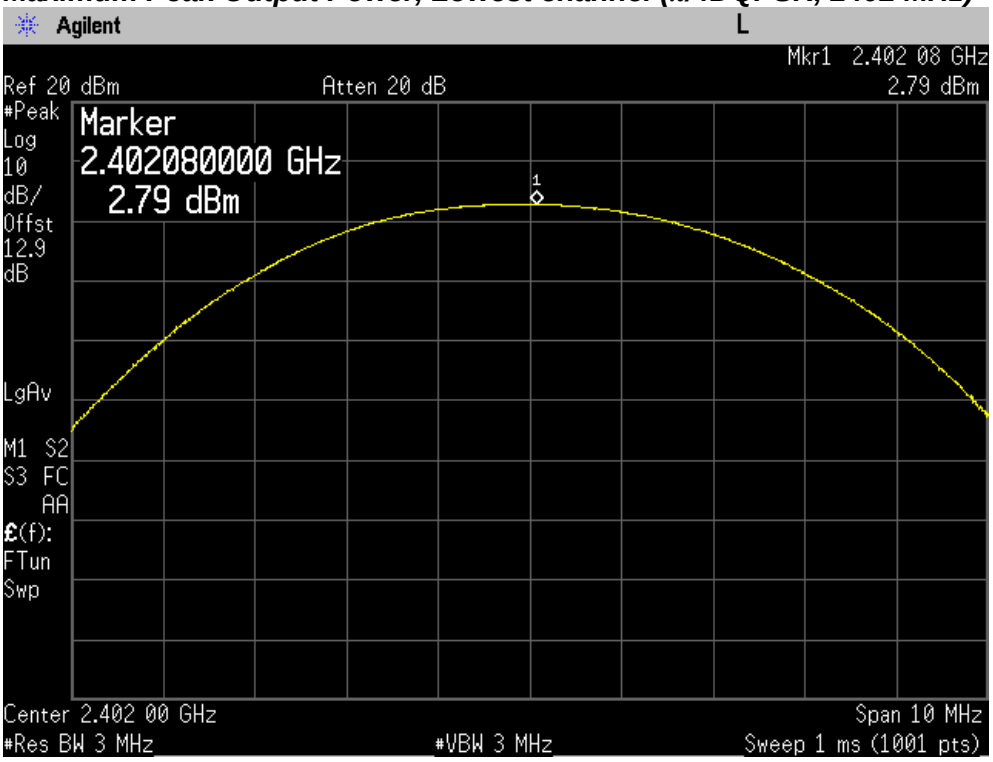


PLOT OF TEST DATA

Maximum Peak Output Power, Highest channel (GFSK, 2480 MHz)

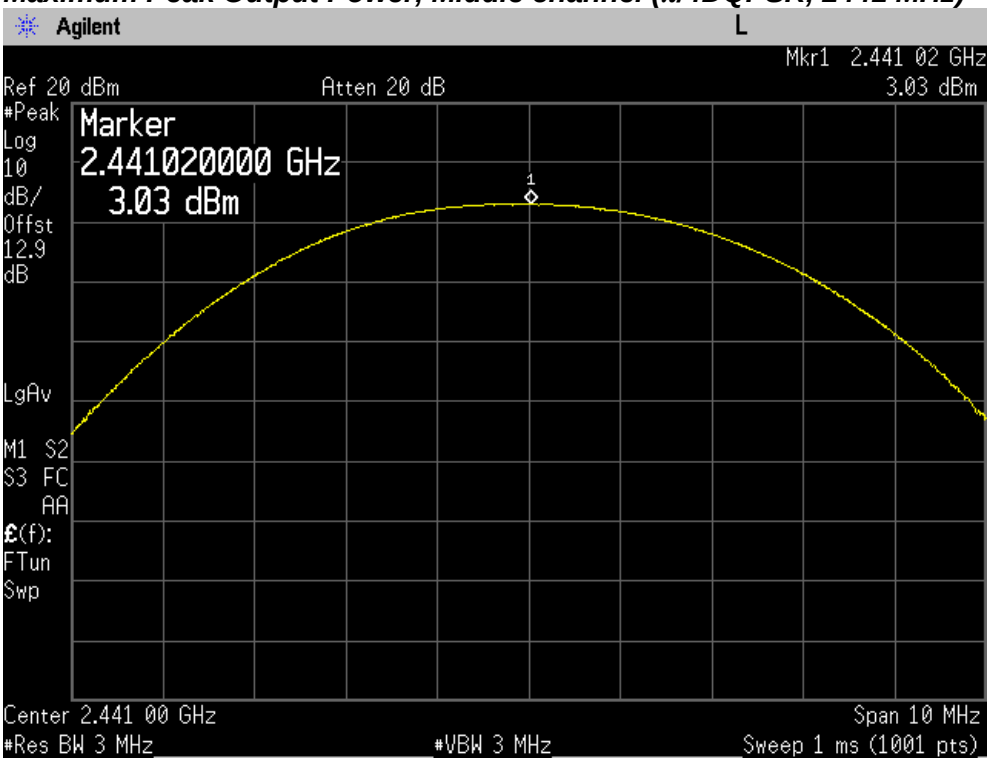


Maximum Peak Output Power, Lowest channel (π/4DQPSK, 2402 MHz)

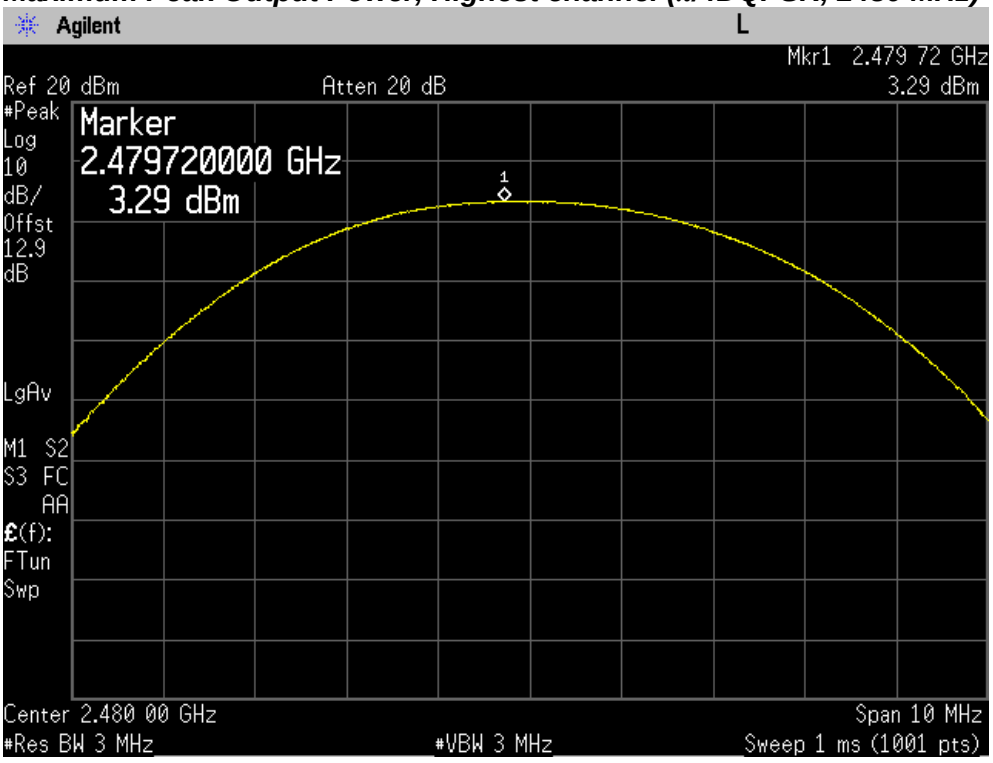


PLOT OF TEST DATA

Maximum Peak Output Power, Middle channel (π/4DQPSK, 2441 MHz)

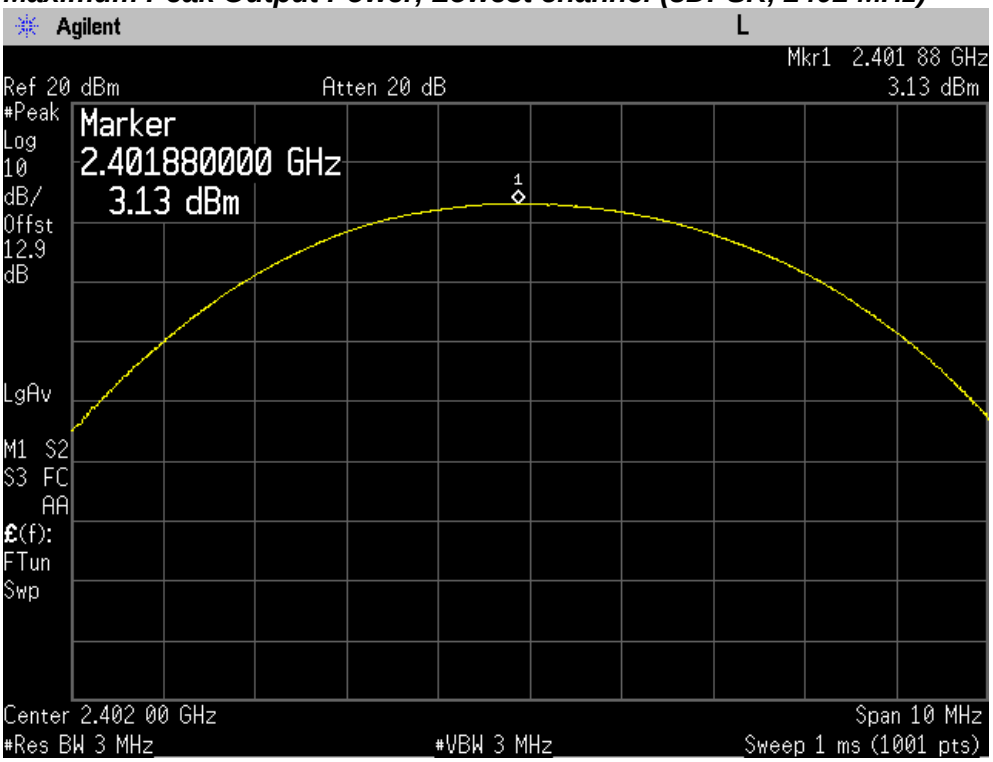


Maximum Peak Output Power, Highest channel (π/4DQPSK, 2480 MHz)

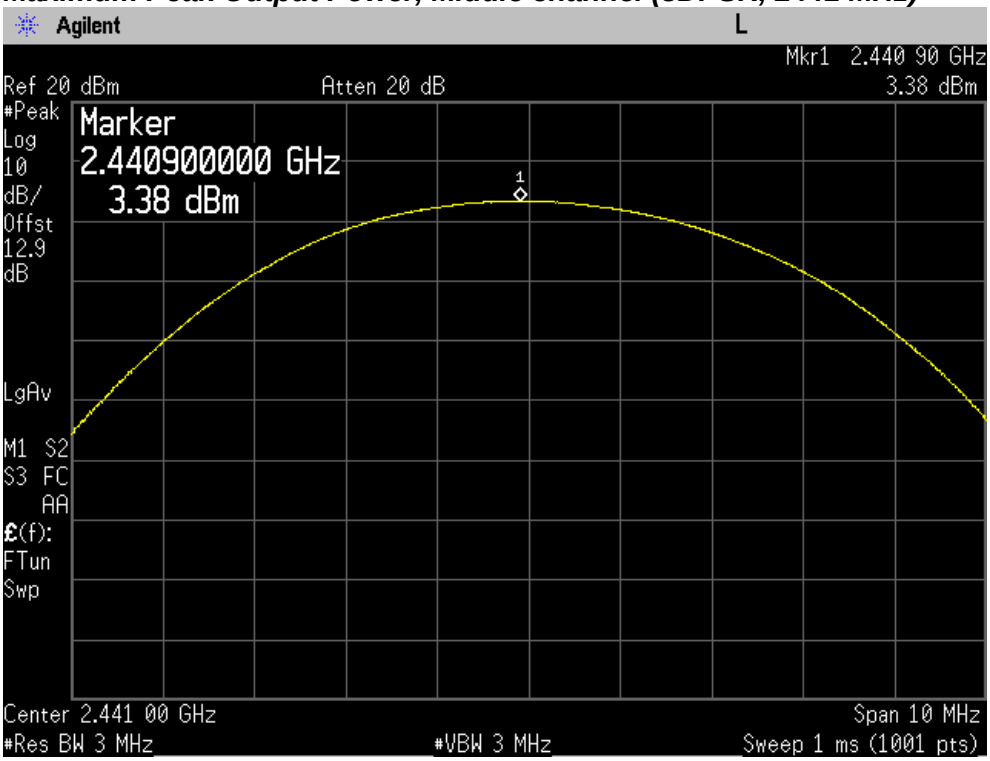


PLOT OF TEST DATA

Maximum Peak Output Power, Lowest channel (8DPSK, 2402 MHz)

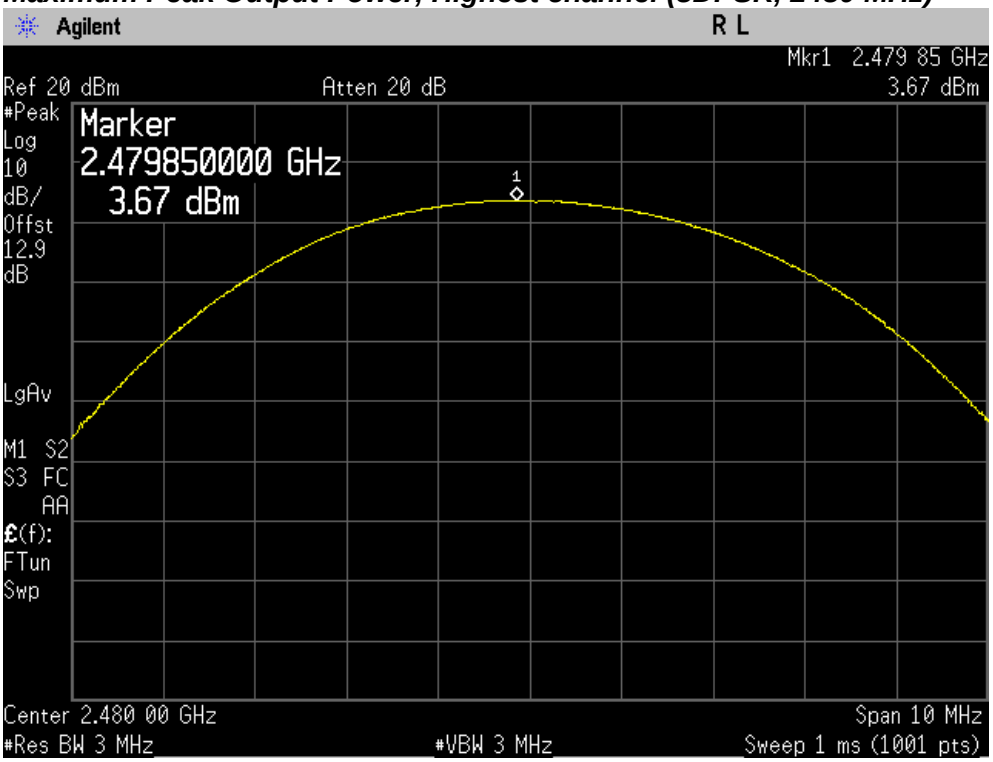


Maximum Peak Output Power, Middle channel (8DPSK, 2441 MHz)



PLOT OF TEST DATA

Maximum Peak Output Power, Highest channel (8DPSK, 2480 MHz)



8.7 Conducted Spurious Emission

FCC §15.247(d) / IC RSS-210 Issue 8, A8.5

Test Mode : Set to Lowest channel, Middle channel and Highest channel

Result:

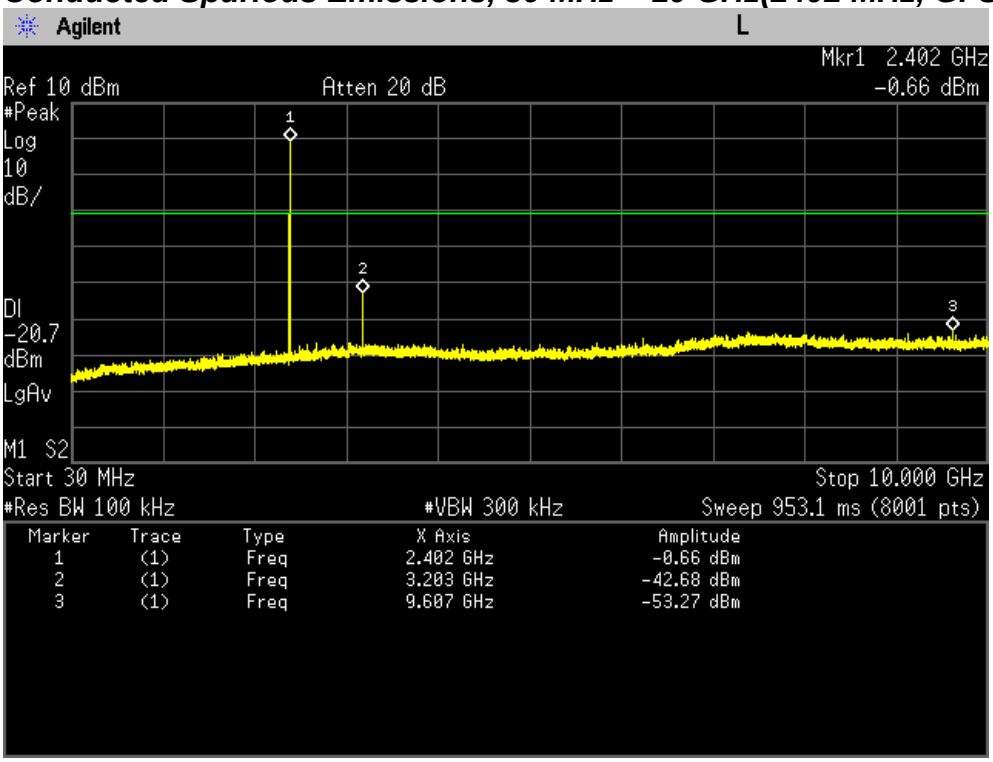
Modulation Mode	Frequency(MHz)	Result	Limit(dBc)
GFSK	2402	More than 30 dBc	20
GFSK	2441	More than 30 dBc	20
GFSK	2480	More than 30 dBc	20
π/4DQPSK	2402	More than 30 dBc	20
π/4DQPSK	2441	More than 30 dBc	20
π/4DQPSK	2480	More than 30 dBc	20
8DPSK	2402	More than 30 dBc	20
8DPSK	2441	More than 30 dBc	20
8DPSK	2480	More than 30 dBc	20

Note:

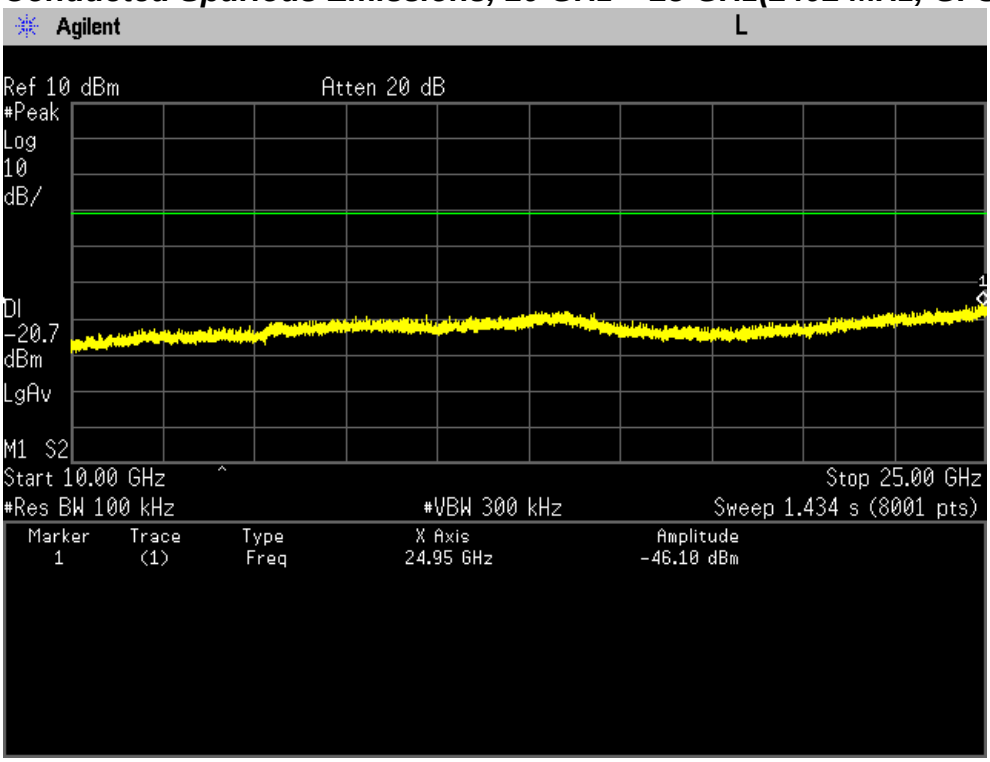
The cable and attenuator loss from 30 MHz to 25 GHz was reflected in spectrum analyzer with correction factor for the spurious emissions test.

PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2402 MHz, GFSK Mode)

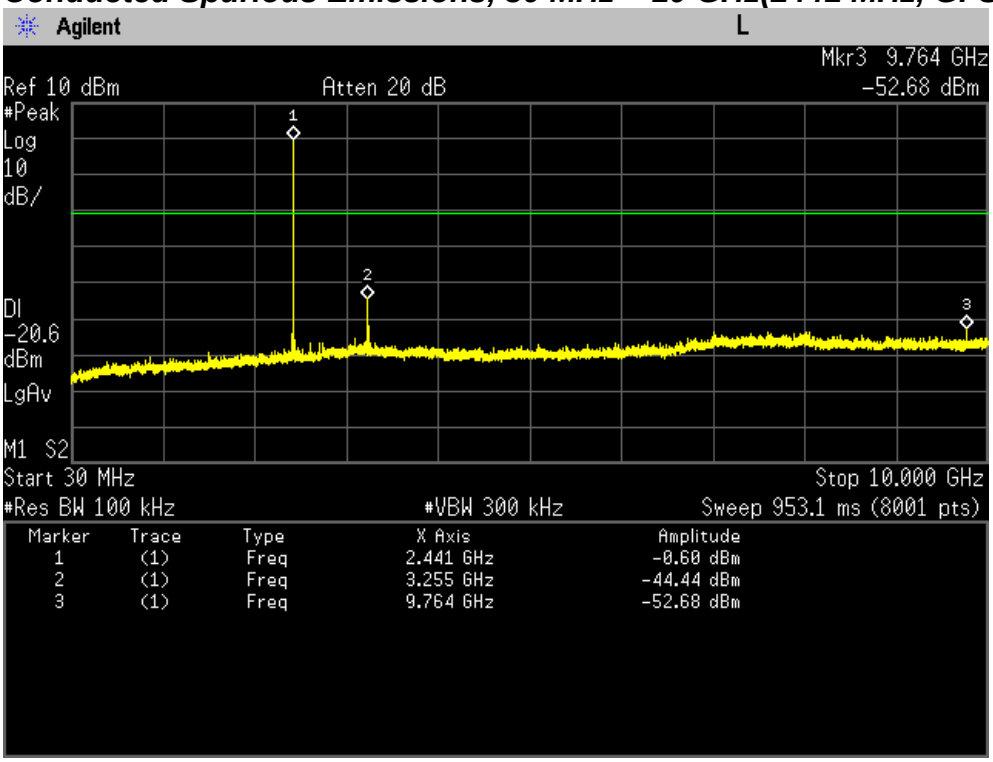


Conducted Spurious Emissions, 10 GHz ~ 25 GHz(2402 MHz, GFSK Mode)

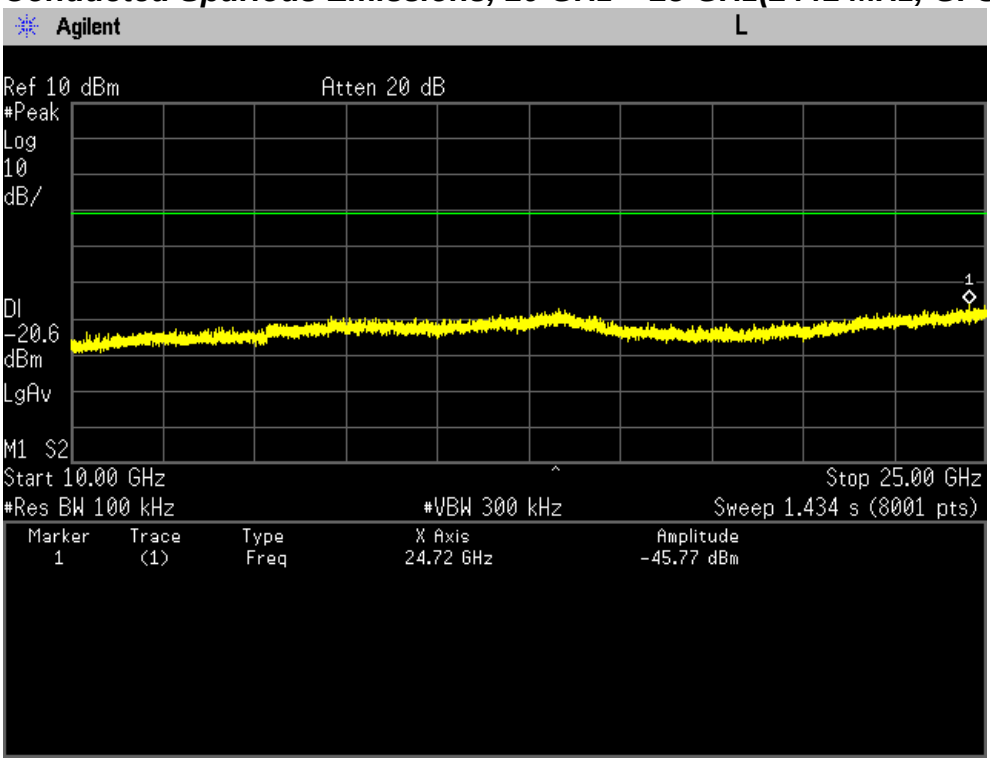


PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2441 MHz, GFSK Mode)

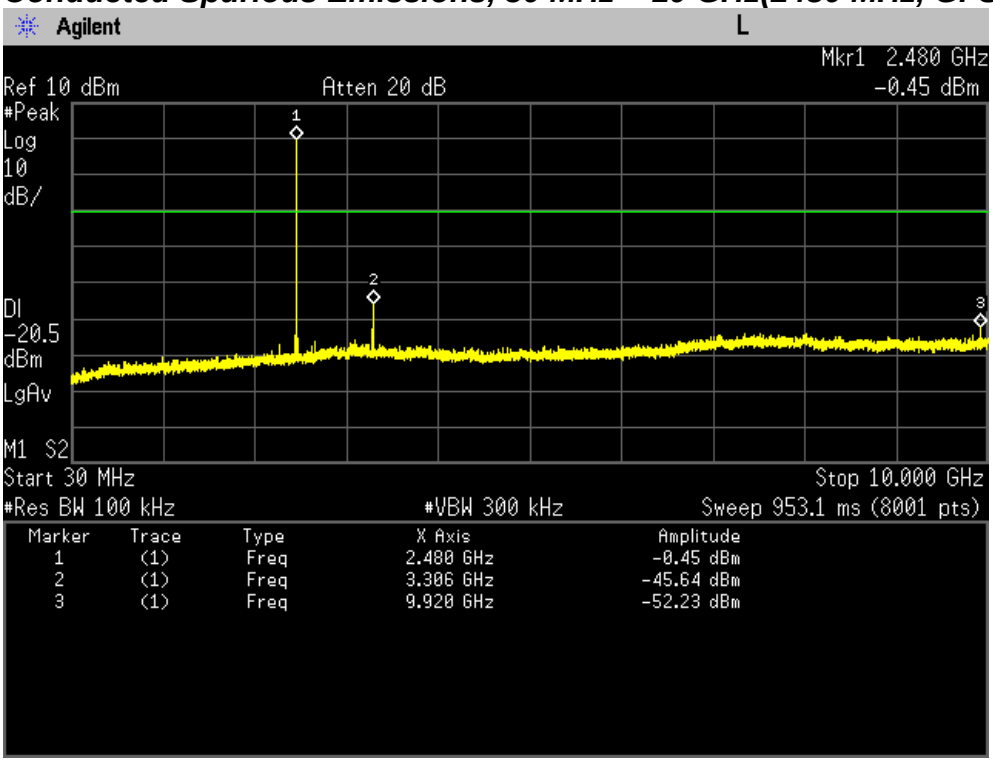


Conducted Spurious Emissions, 10 GHz ~ 25 GHz(2441 MHz, GFSK Mode)

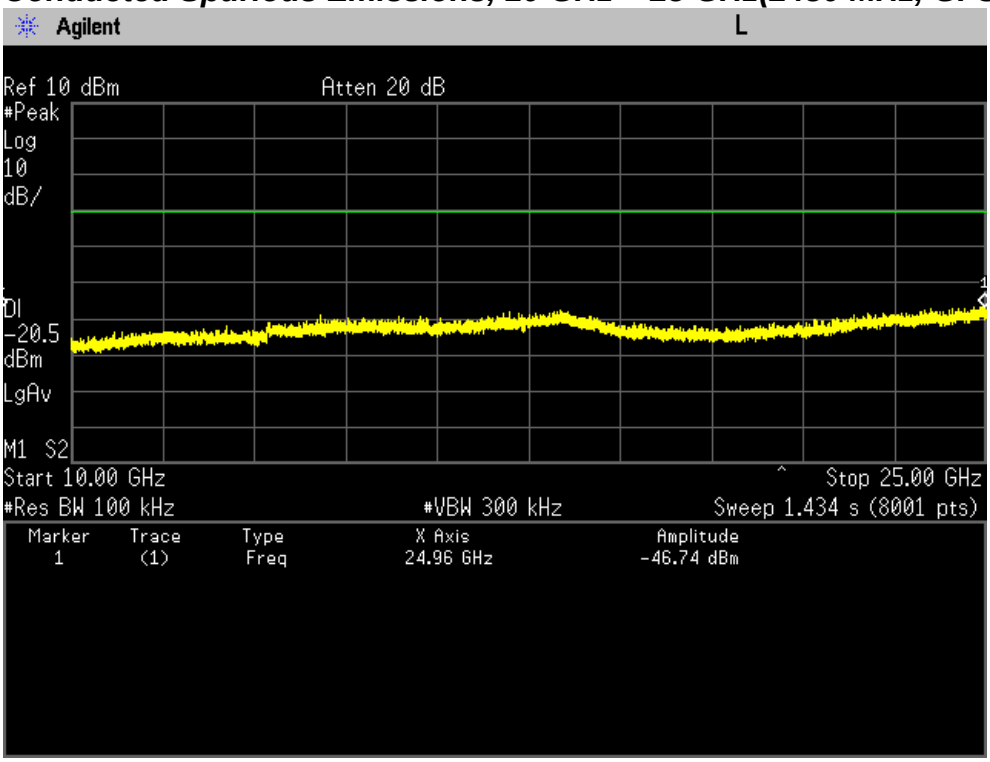


PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2480 MHz, GFSK Mode)

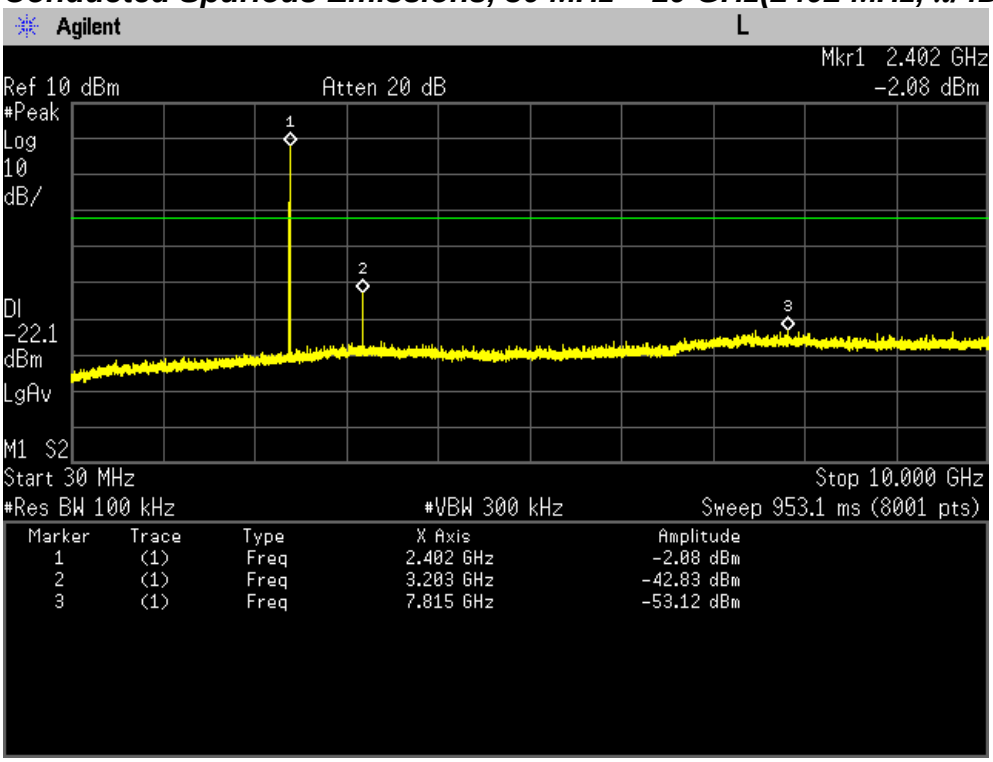


Conducted Spurious Emissions, 10 GHz ~ 25 GHz(2480 MHz, GFSK Mode)

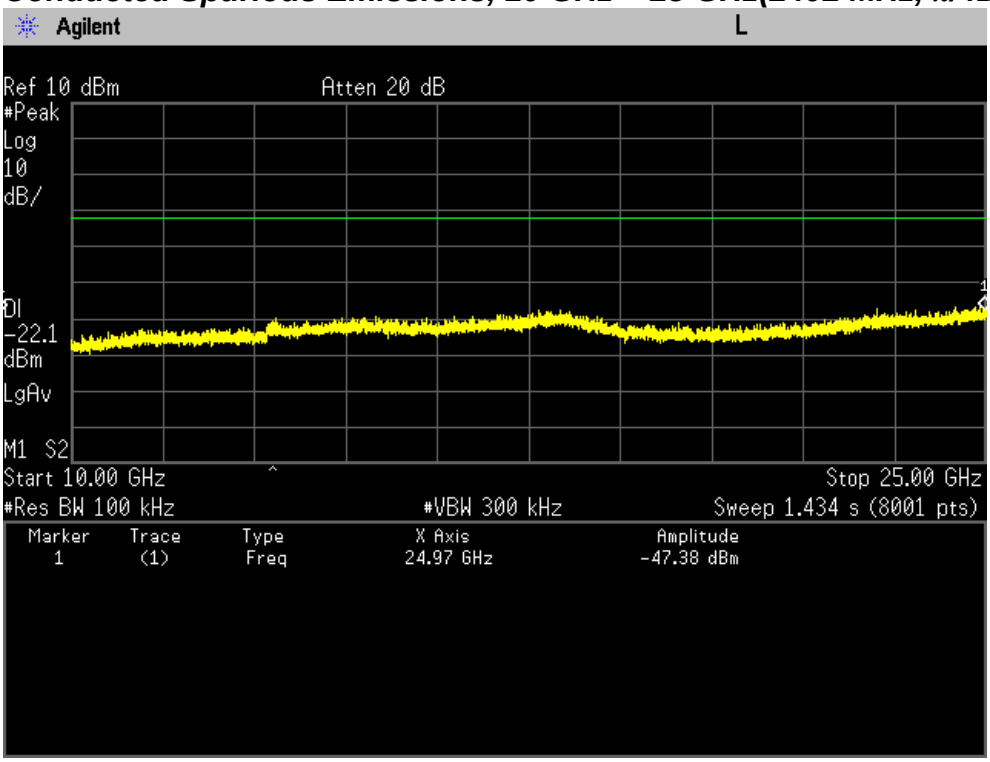


PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2402 MHz, π/4DQPSK Mode)

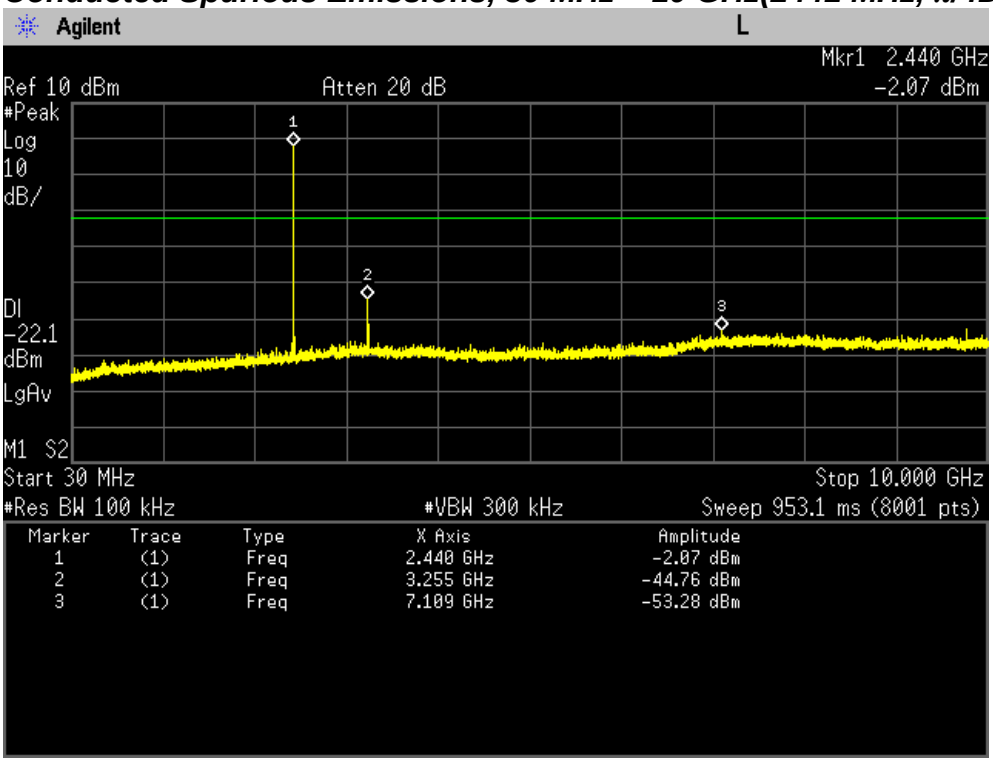


Conducted Spurious Emissions, 10 GHz ~ 25 GHz(2402 MHz, π/4DQPSK Mode)

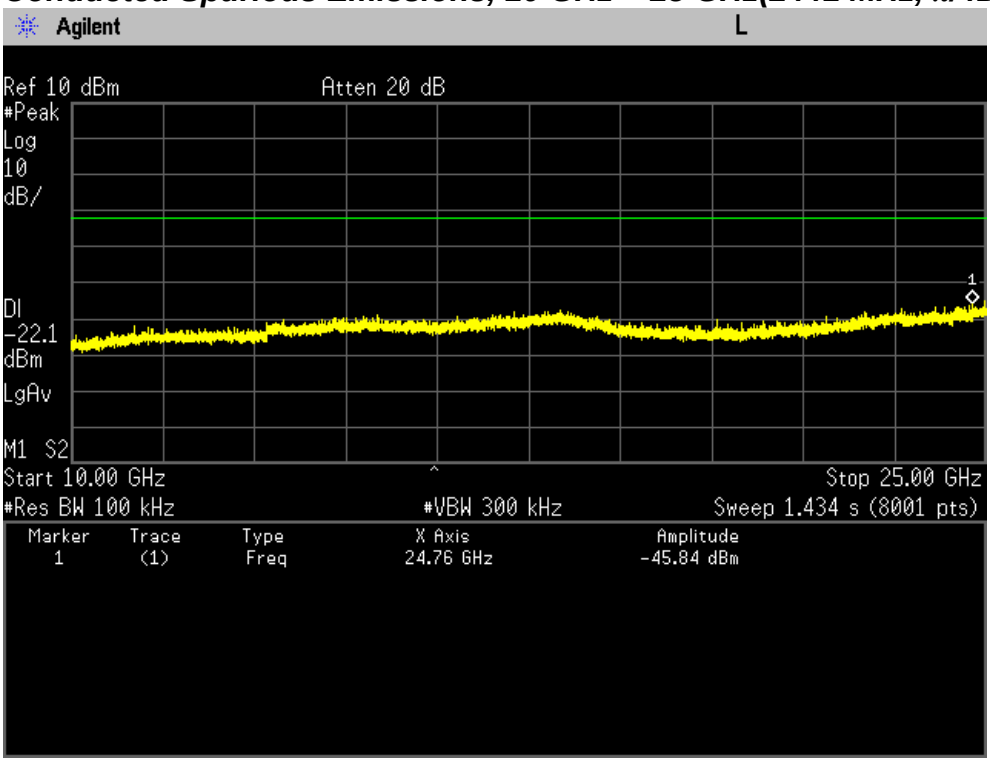


PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2441 MHz, π/4DQPSK Mode)

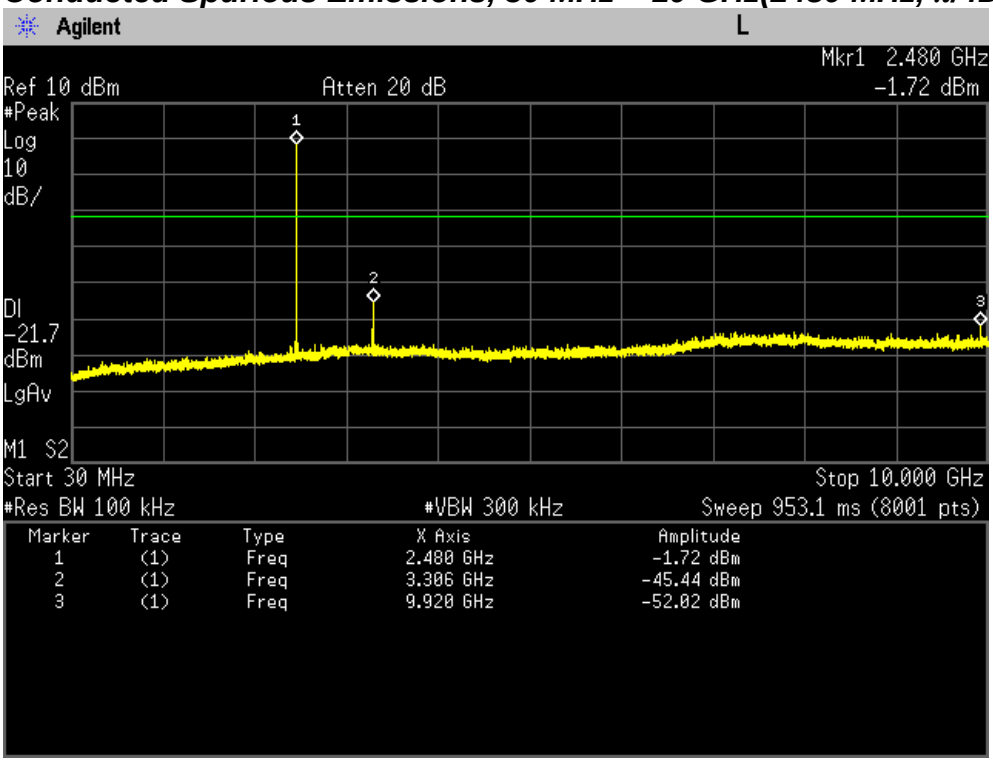


Conducted Spurious Emissions, 10 GHz ~ 25 GHz(2441 MHz, π/4DQPSK Mode)

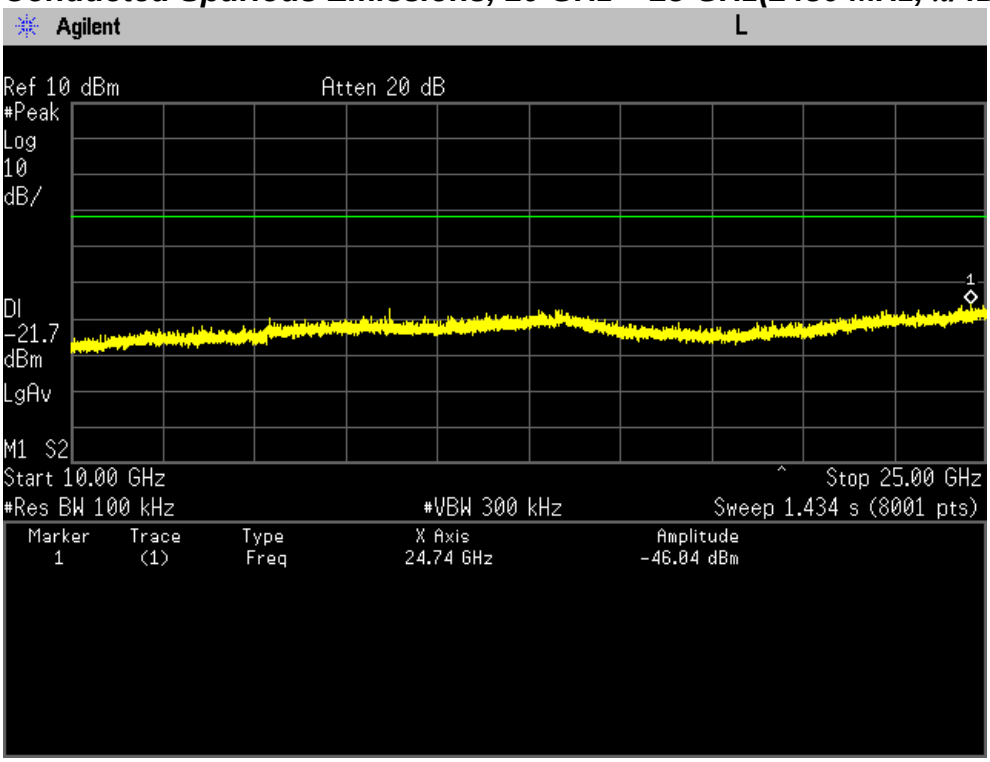


PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2480 MHz, π/4DQPSK Mode)

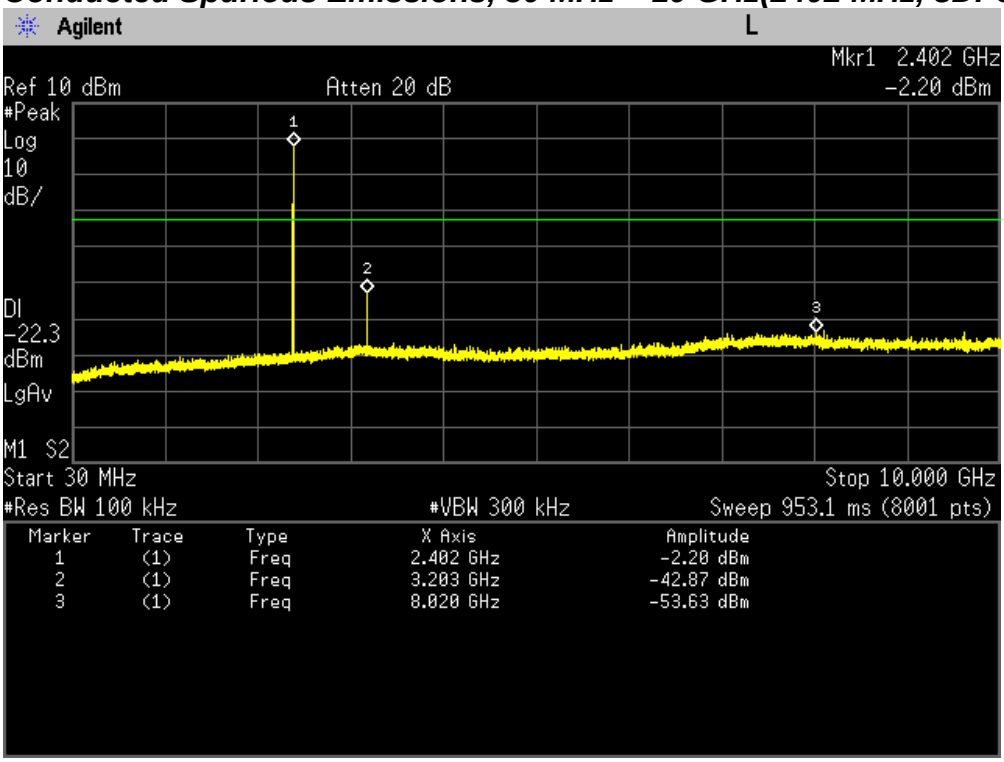


Conducted Spurious Emissions, 10 GHz ~ 25 GHz(2480 MHz, π/4DQPSK Mode)

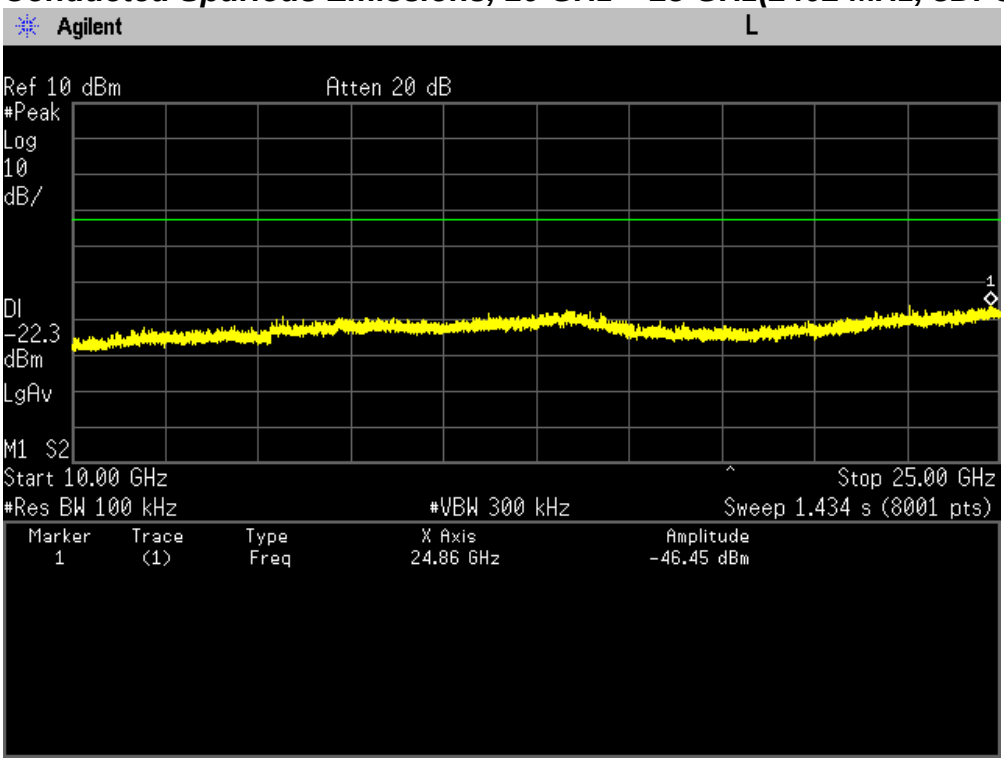


PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2402 MHz, 8DPSK Mode)

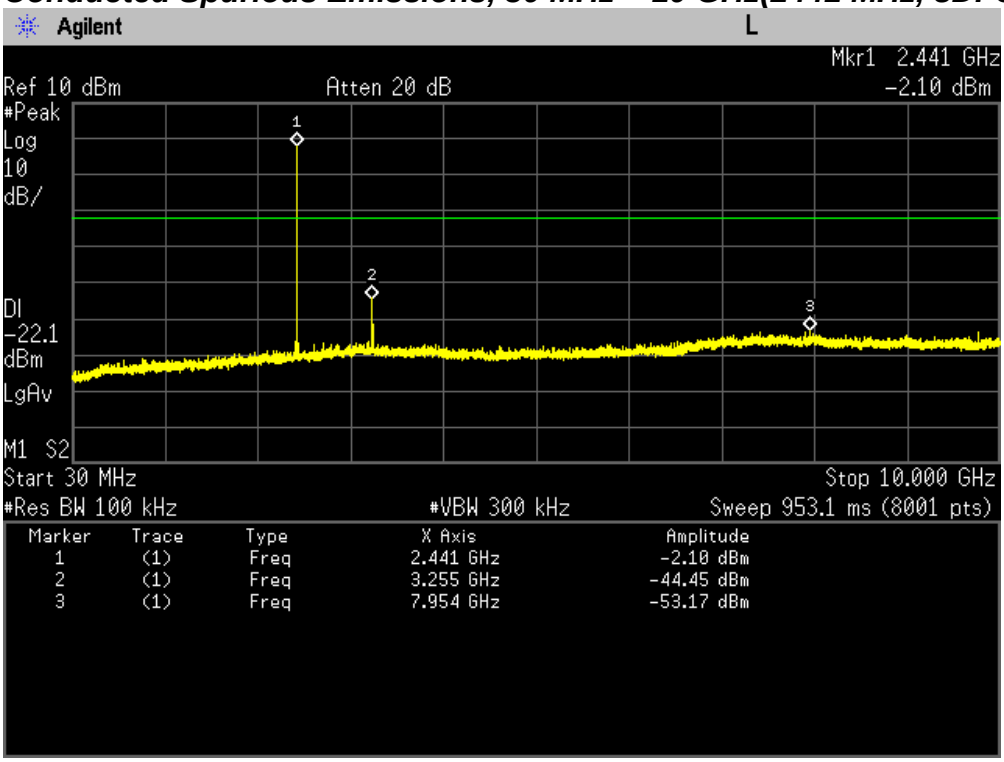


Conducted Spurious Emissions, 10 GHz ~ 25 GHz(2402 MHz, 8DPSK Mode)

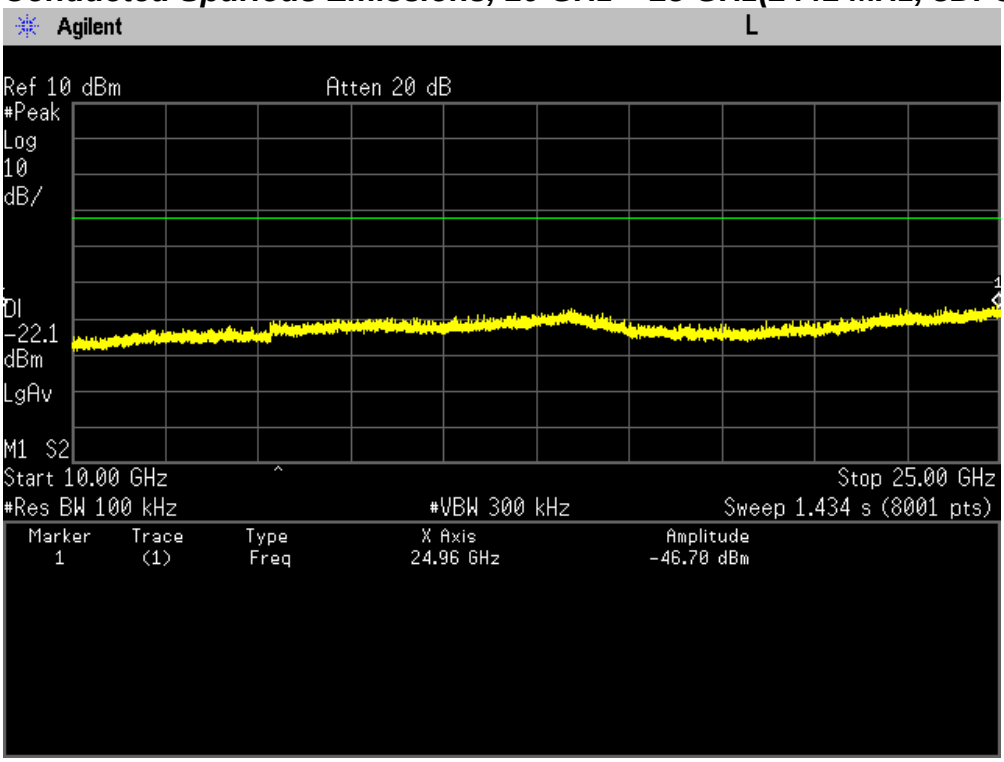


PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2441 MHz, 8DPSK Mode)

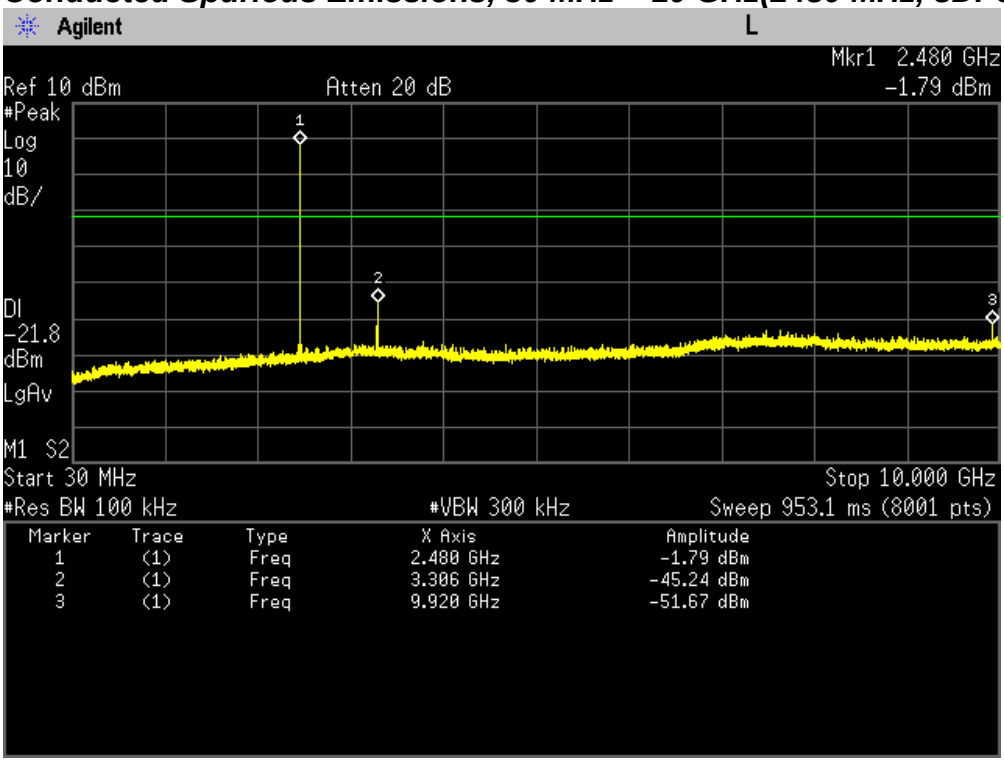


Conducted Spurious Emissions, 10 GHz ~ 25 GHz(2441 MHz, 8DPSK Mode)

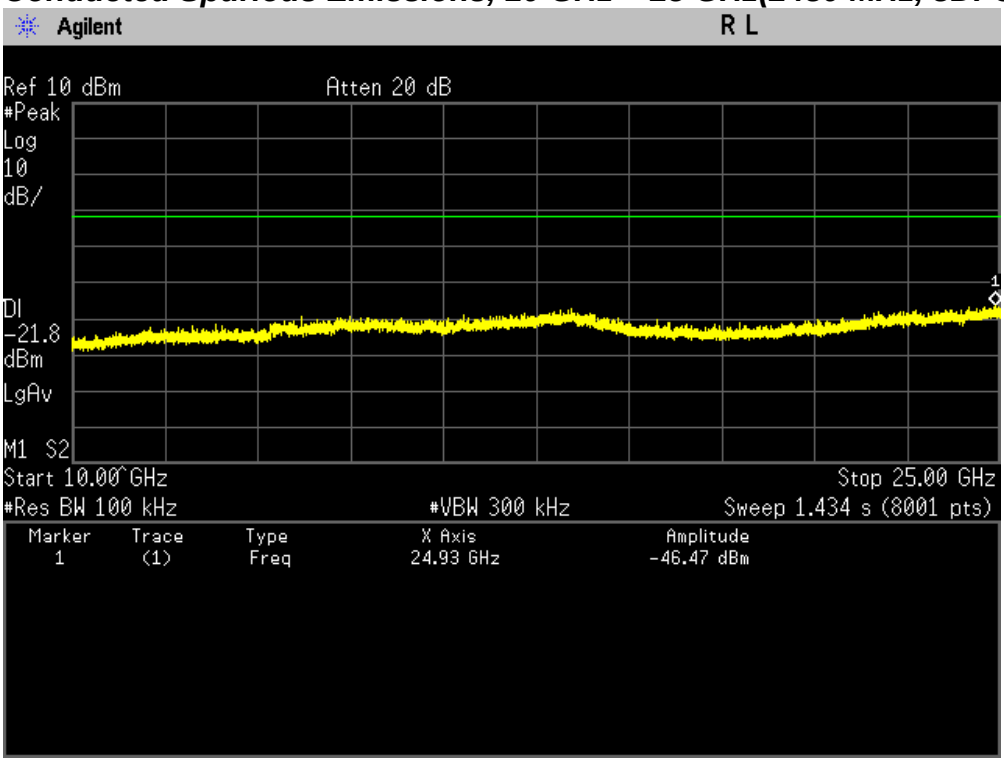


PLOT OF TEST DATA

Conducted Spurious Emissions, 30 MHz ~ 10 GHz(2480 MHz, 8DPSK Mode)

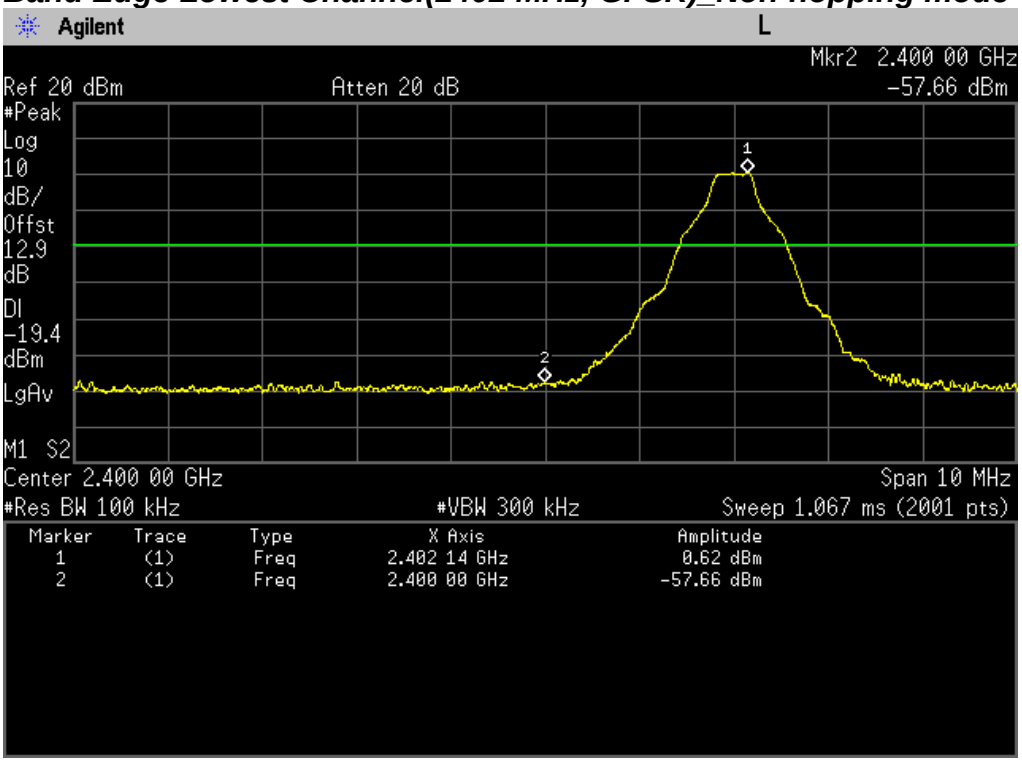


Conducted Spurious Emissions, 10 GHz ~ 25 GHz(2480 MHz, 8DPSK Mode)

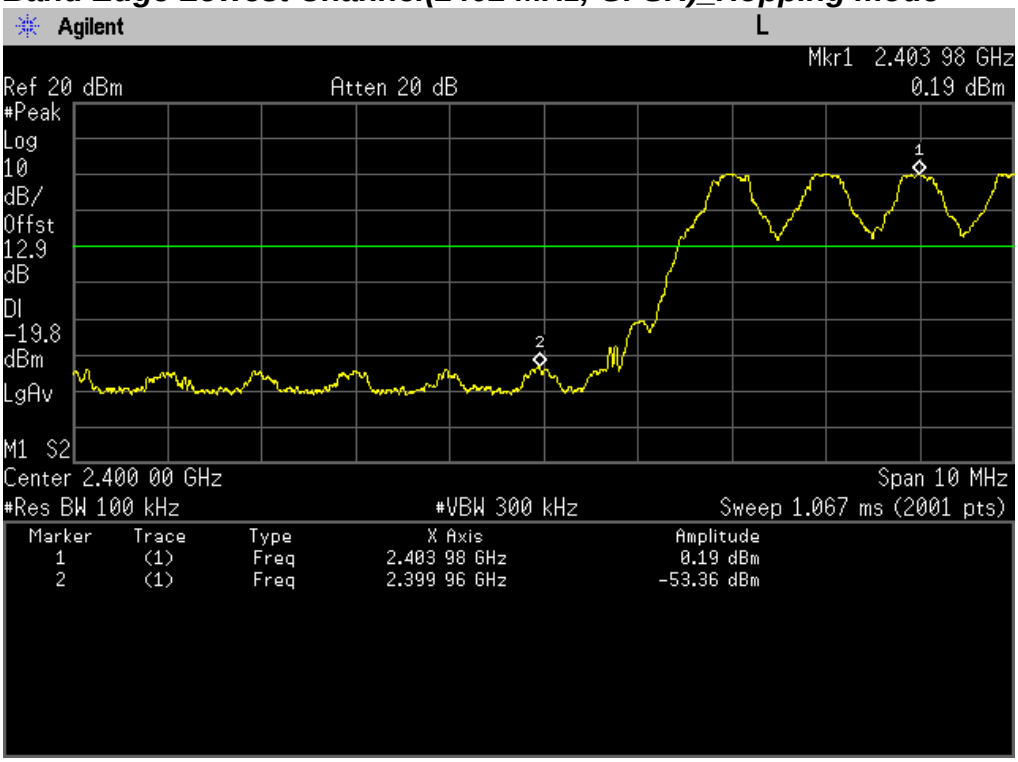


PLOT OF TEST DATA

Band Edge Lowest Channel(2402 MHz, GFSK)_Non-hopping mode

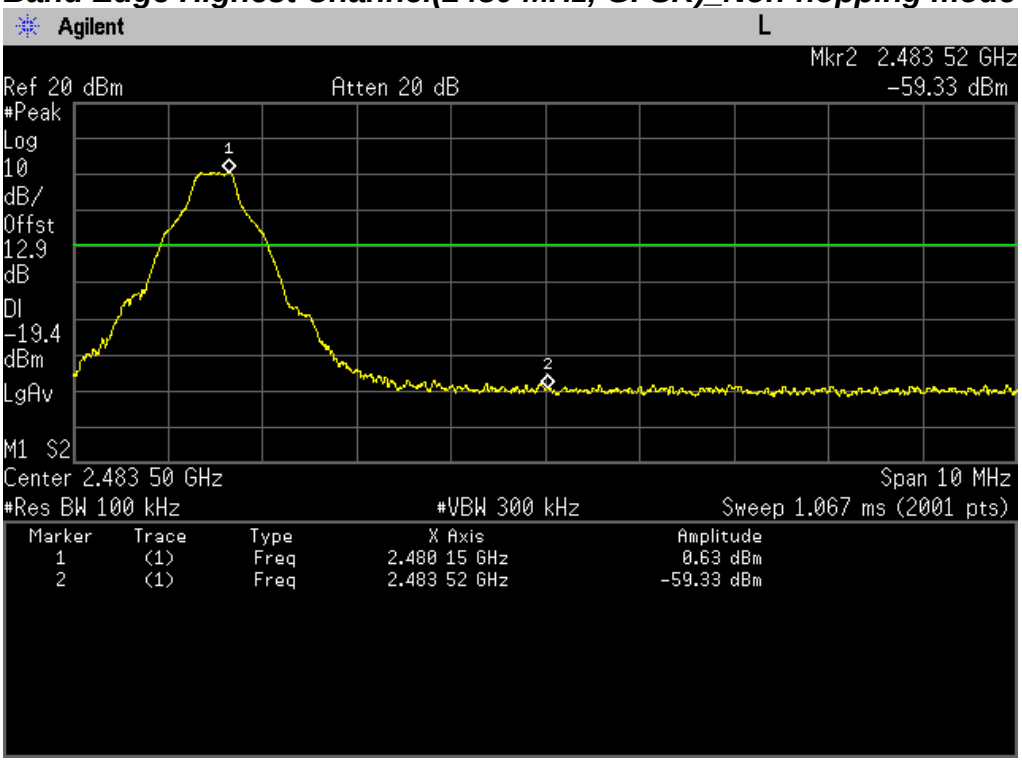


Band Edge Lowest Channel(2402 MHz, GFSK)_Hopping mode

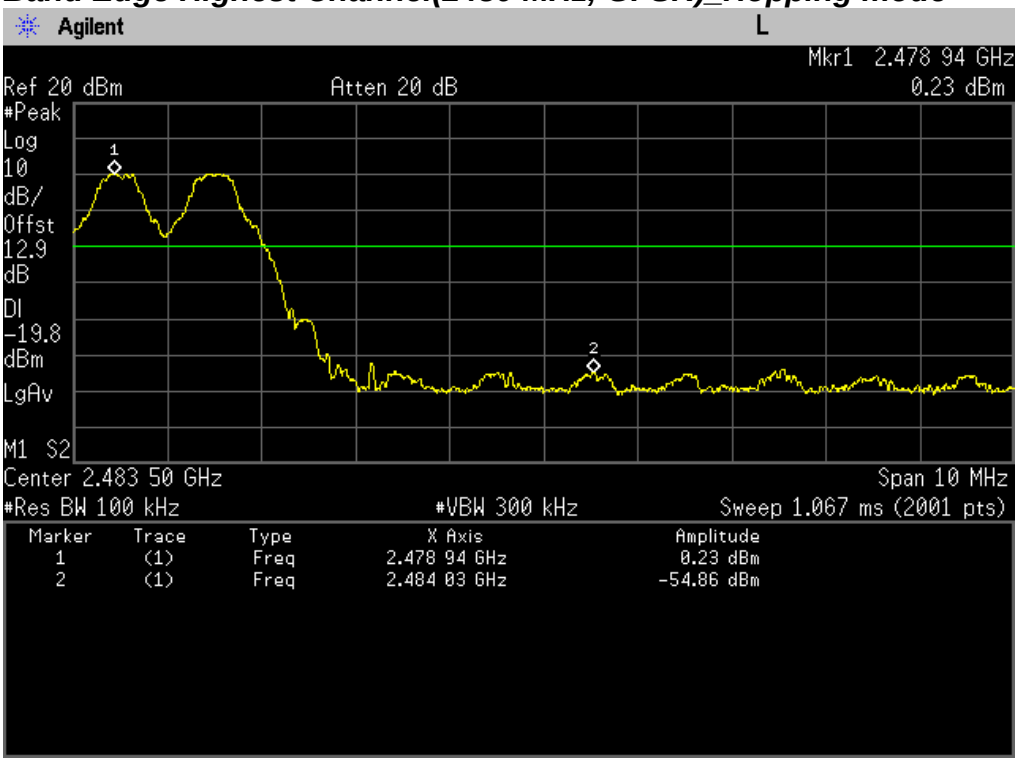


PLOT OF TEST DATA

Band Edge Highest Channel(2480 MHz, GFSK)_Non-hopping mode

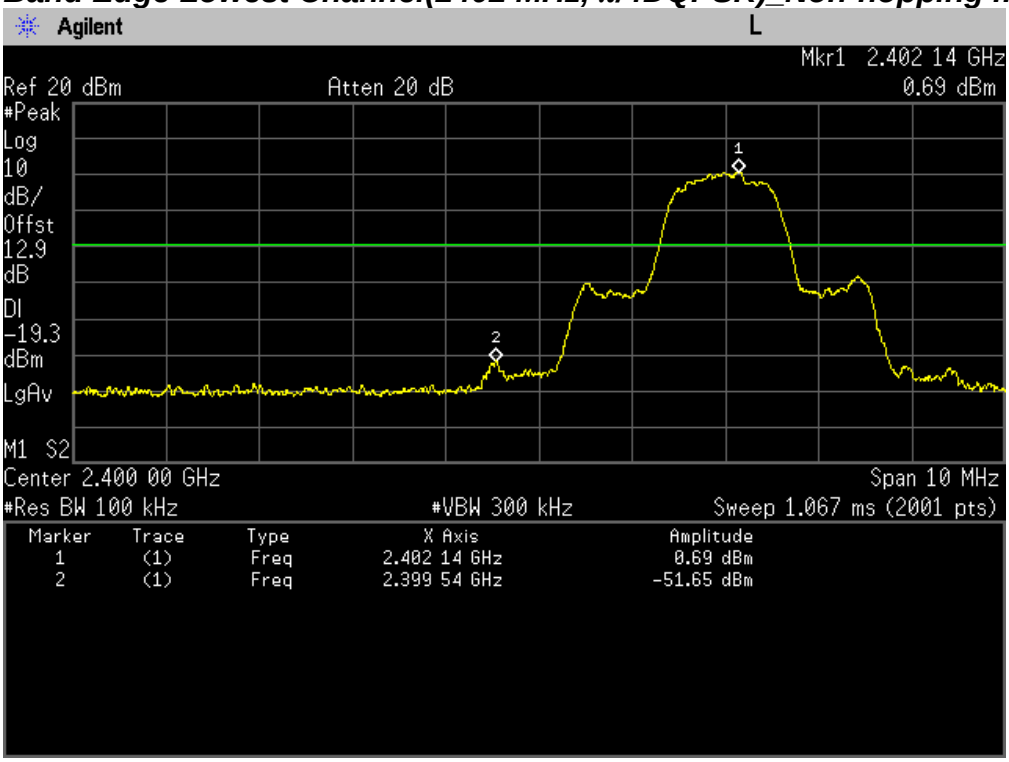


Band Edge Highest Channel(2480 MHz, GFSK)_Hopping mode

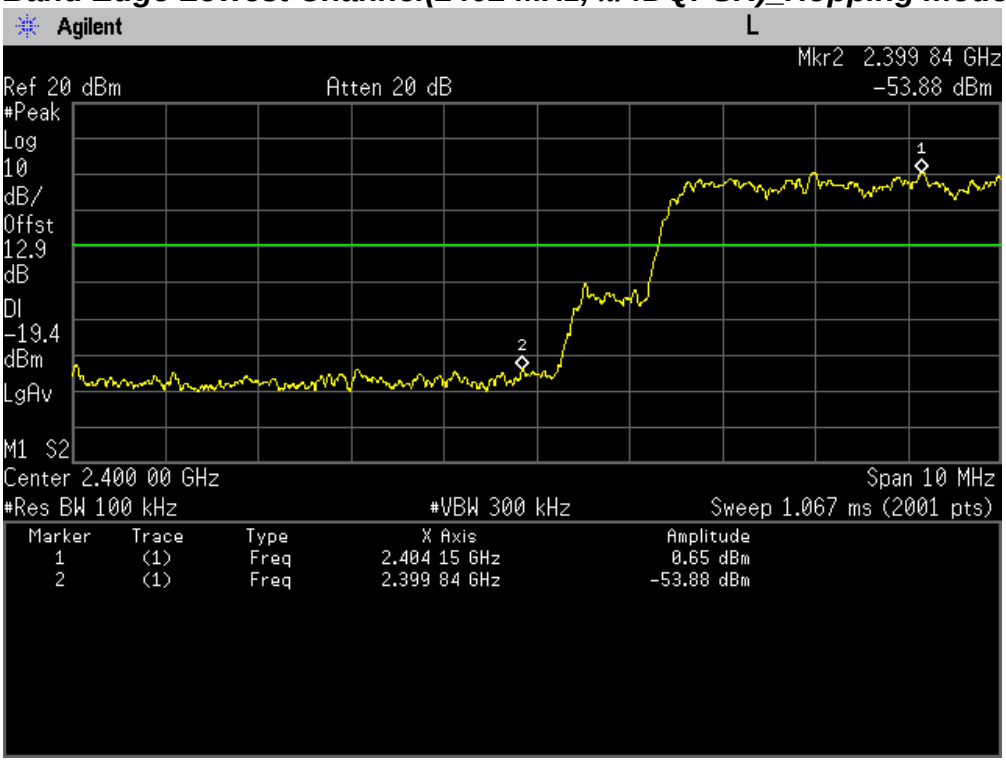


PLOT OF TEST DATA

Band Edge Lowest Channel(2402 MHz, π/4DQPSK)_Non-hopping mode

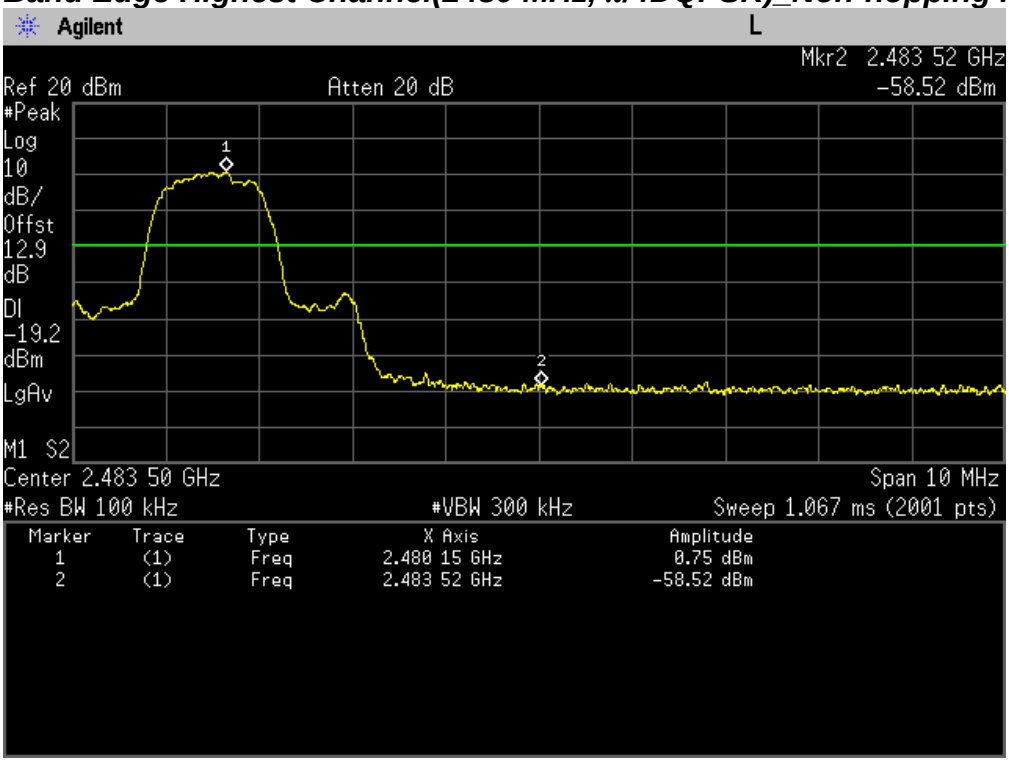


Band Edge Lowest Channel(2402 MHz, π/4DQPSK)_Hopping mode

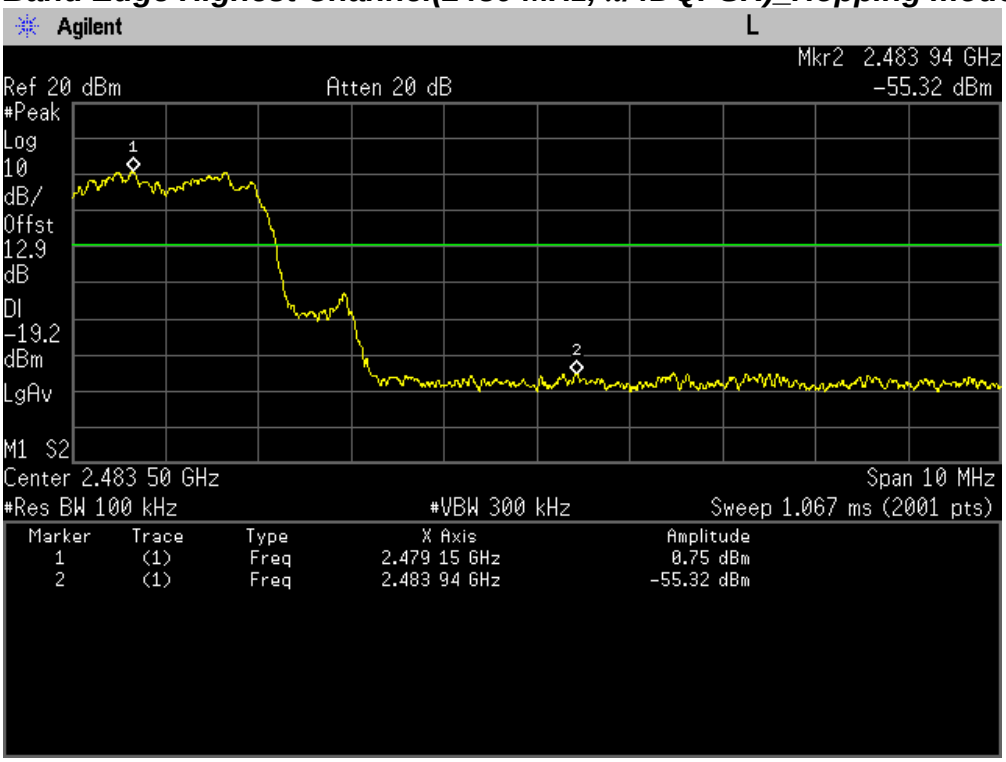


PLOT OF TEST DATA

Band Edge Highest Channel(2480 MHz, π/4DQPSK)_Non-hopping mode

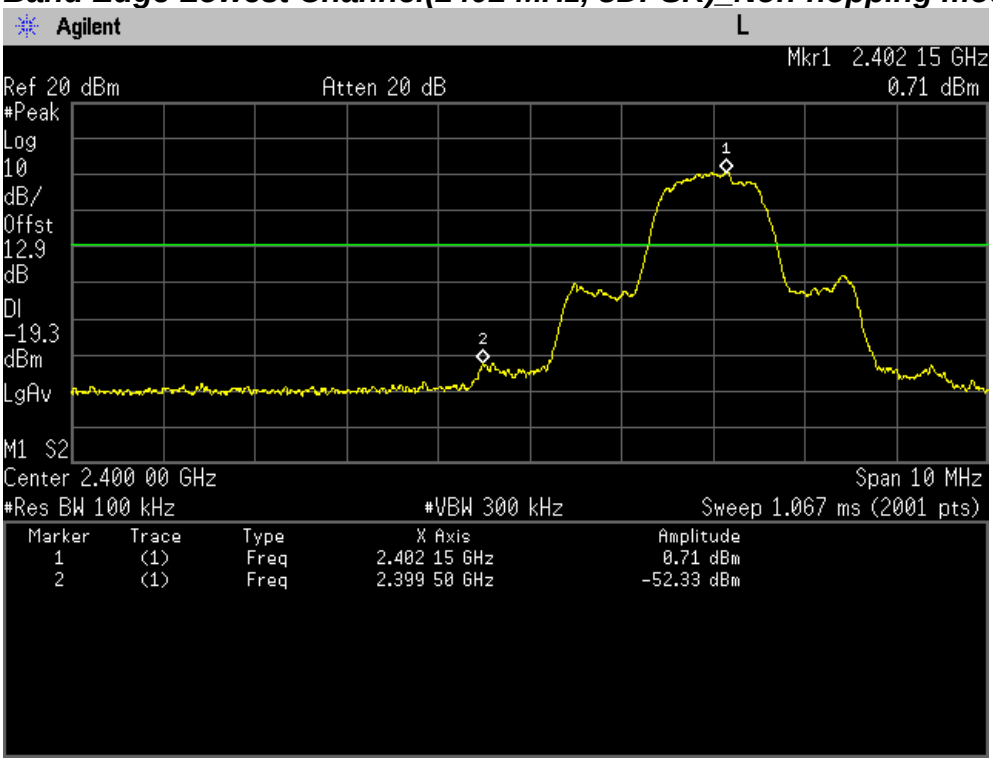


Band Edge Highest Channel(2480 MHz, π/4DQPSK)_Hopping mode

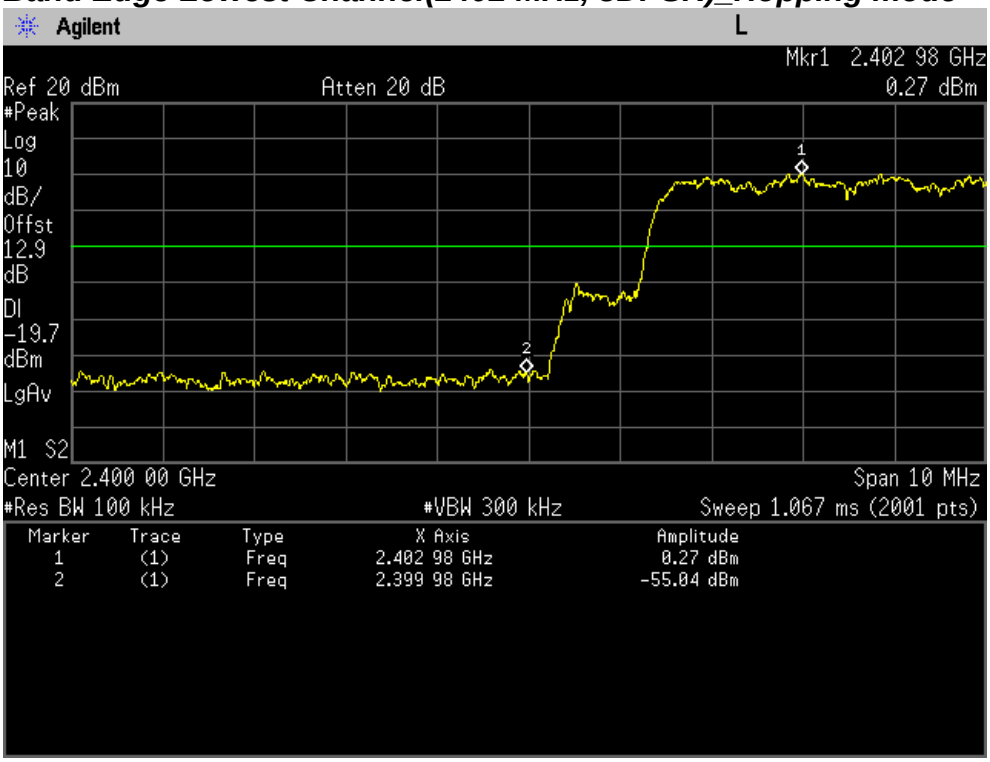


PLOT OF TEST DATA

Band Edge Lowest Channel(2402 MHz, 8DPSK)_Non-hopping mode

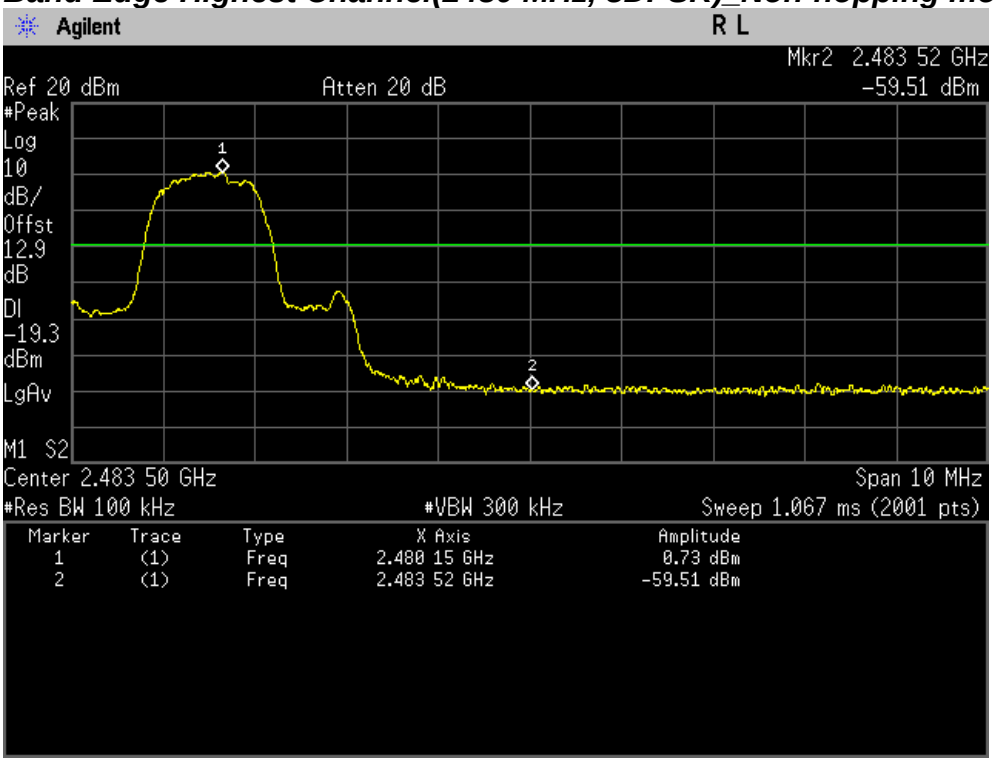


Band Edge Lowest Channel(2402 MHz, 8DPSK)_Hopping mode

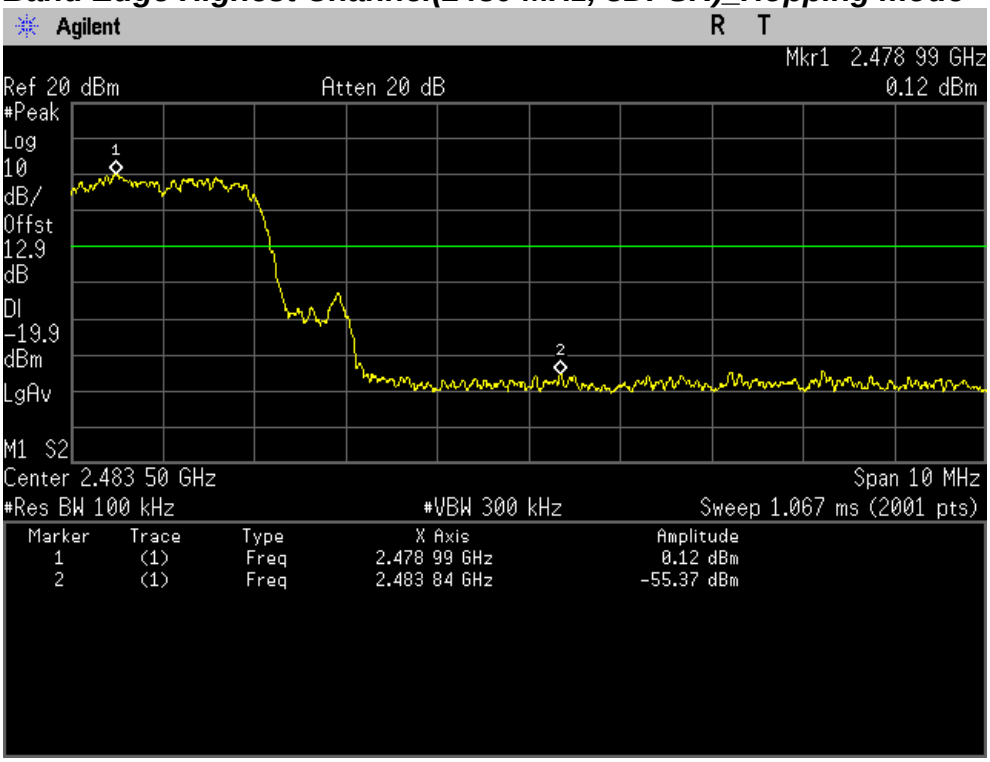


PLOT OF TEST DATA

Band Edge Highest Channel(2480 MHz, 8DPSK)_Non-hopping mode



Band Edge Highest Channel(2480 MHz, 8DPSK)_Hopping mode



8.8 Radiated Spurious Emissions

FCC §15.247(d) / IC RSS-210 Issue 8, A8.5

Test Mode : Set to Lowest channel, Middle channel and Highest channel

Result:

Lowest Channel

Frequency (MHz)	Reading (dBµV)	Pol* (H/V)	mode	AF+CL+Amp (dB)**	Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)
4804.12	42.7	H	peak	9.0	51.7	74.0	22.3
4804.12	35.7	H	average	9.0	44.7	54.0	9.3

Middle Channel

Frequency (MHz)	Reading (dBµV)	Pol* (H/V)	mode	AF+CL+Amp (dB)**	Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)
4882.13	39.5	H	peak	9.2	48.7	74.0	25.3
4882.13	32.7	H	average	9.2	41.9	54.0	12.1

Highest Channel

Frequency (MHz)	Reading (dBµV)	Pol* (H/V)	mode	AF+CL+Amp (dB)**	Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)
4960.13	40.8	H	peak	9.4	50.2	74.0	23.8
4960.13	34.1	H	average	9.4	43.5	54.0	10.5

Notes:

1. *Pol. H = Horizontal V = Vertical
2. **AF + CL + Amp. = Antenna Factor + Cable Loss + Amplifier.
3. Other spurious was under 20 dB below Fundamental.
4. 8DPSK modulation mode was the worst condition.
5. The radiated emissions testing were made by rotating EUT through three orthogonal axes and rotating the receive antenna with horizontal, Vertical polarization. The worst data was recorded.
6. Peak emissions were measured using RBW = 1 MHz, VBW = 1 MHz, Detector = Peak.
7. Average emissions were measured using RBW = 1 MHz, VBW = 1 kHz (> 1/τ Hz, where τ is pulse width on second), Detector = Peak.
8. The spectrum was measured from 9 kHz to 10^{th} harmonic and the worst-case emissions were reported. No significant emissions were found beyond the second harmonic for this device.

8.9 Radiated Restricted Band Edge

FCC §15.247(d), IC RSS-210 Issue 8, A8.5

Test Mode : Set to Lowest channel, Middle channel and Highest channel

GFSK mode

Lowest Channel

Frequency (MHz)	Reading (dBµV)	Pol* (H/V)	mode	AF+CL+Amp (dB)**	Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)
2389.93	45.60	H	peak	-0.80	44.80	74.0	29.20
2389.93	38.70	H	average	-0.80	37.90	54.0	16.10

Highest Channel

Frequency (MHz)	Reading (dBµV)	Pol* (H/V)	mode	AF+CL+Amp (dB)**	Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)
2483.50	55.40	H	peak	-0.20	55.20	74.0	18.80
2483.50*)	39.67	H	average	-0.20	39.47	54.0	14.53

***π/4DQPSK* mode**

Lowest Channel

Frequency (MHz)	Reading (dBµV)	Pol* (H/V)	mode	AF+CL+Amp (dB)**	Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)
2389.70	45.70	H	peak	-0.80	44.90	74.0	29.10
2389.93	37.80	H	average	-0.80	37.00	54.0	17.00

Highest Channel

Frequency (MHz)	Reading (dBµV)	Pol* (H/V)	mode	AF+CL+Amp (dB)**	Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)
2483.50	58.10	H	peak	-0.20	57.90	74.0	16.10
2483.50*)	39.17	H	average	-0.20	38.97	54.0	15.03

8DPSK

Lowest Channel

Frequency (MHz)	Reading (dBµV)	Pol* (H/V)	mode	AF+CL+Amp (dB)**	Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)
2389.93	45.80	H	peak	-0.80	45.00	74.0	29.00
2389.93	37.40	H	average	-0.80	36.60	54.0	17.40

Highest Channel

Frequency (MHz)	Reading (dBµV)	Pol* (H/V)	mode	AF+CL+Amp (dB)**	Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)
2483.50	60.10	H	peak	-0.20	59.90	74.0	14.10
2483.50*)	39.36	H	average	-0.20	39.16	54.0	14.84

Notes:

*1. *Pol. H = Horizontal V = Vertical*

*2. **AF + CL + Amp. = Antenna Factor + Cable Loss + Amplifier.*

3. The radiated emissions testing were made by rotating EUT through three orthogonal axes and rotating the receive antenna with horizontal, Vertical polarization. The worst data was recorded.

4. Peak emissions were measured using RBW = 1 MHz, VBW = 1 MHz, Detector = Peak.

5. Average emissions were measured using RBW = 1 MHz, VBW = 1 kHz (> 1/τ Hz, where τ is pulse width on second), Detector = Peak.

*6. *) Band edge measurement has been performed according to "Marker-Delta Method" in FCC Public Notice DA00-705.*

9. TEST EQUIPMENT

No.	Instrument	Manufacturer	Model	Serial No.	Calibration Date	Calibration Interval
1	*Test Receiver	R & S	ESCS 30	833364/020	Jan. 09 2013	1 year
2	*Test Receiver	R & S	ESCS 30	100302	Oct. 08 2012	1 year
3	*Amplifier	HP	8447F	2805A03427	Jul. 17 2012	1 year
4	*Amplifier	Sonoma Instrument	310N	291916	Jul. 16 2012	1 year
5	*Amplifier	R & S	SCU18	10065	Apr. 05 2012	1 year
6	*Amplifier	R & S	SCU26	10011	Jun. 01 2012	1 year
7	Amplifier	R & S	SCU40	10008	Jun. 01 2012	1 year
8	*Pre Amplifier	HP	8449B	3008A00107	Jan. 09 2013	1 year
9	*Pre Amplifier	HP	8447F	2805A03351	Jul. 17 2012	1 year
10	*Spectrum Analyzer	Agilent	E4440A	MY44303257	Jul. 16 2012	1 year
11	*Spectrum Analyzer	Agilent	E4440A	MY44022567	Apr. 05 2012	1 year
12	*Spectrum Analyzer	R & S	FSP40	100361	Jul. 17 2012	1 year
13	*Loop Antenna	R & S	HFH2-Z2	100279	Feb. 21 2012	2 year
14	Wideband Power Sensor	R & S	NRP-Z81	100634	Apr. 05 2012	1 year
15	*Biconical Log Antenna	ARA	LPB-2520/A	1180	Apr.26, 2012	2 year
16	*Horn Antenna	SCHWARZBECK	BBHA9120D	9120D-474	Aug.13, 2012	2 year
17	*Horn Antenna	Q-par Angus	QSH20S20	8179	Mar. 28 2011	2 year
18	Horn Antenna	Q-par Angus	QSH22K20	8180	Mar. 28 2011	2 year
19	Trilog-Broadband Antenna	SCHWARZBECK	VULB 9163	9163-454	Feb. 24 2012	2 year
20	*Trilog-Broadband Antenna	SCHWARZBECK	VULB 9168	9168-257	Apr. 26 2012	2 year
21	LISN	R & S	ESH3-Z5	833874/006	Oct. 08 2012	1 year
22	LISN	R & S	ESH2-Z5	100227	Apr. 04 2012	1 year
23	*Position Controller	DAEIL EMC	N/A	N/A	N/A	N/A
24	*Turn Table	DAEIL EMC	N/A	N/A	N/A	N/A
25	*Antenna Mast	DAEIL EMC	N/A	N/A	N/A	N/A
26	*Anechoic Chamber	EM Eng.	N/A	N/A	N/A	N/A
27	*Shielded Room	EM Eng.	N/A	N/A	N/A	N/A
28	*Position Controller	Seo-Young EMC	N/A	N/A	N/A	N/A
29	*Turn Table	Seo-Young EMC	N/A	N/A	N/A	N/A
30	*Antenna Mast	Seo-Young EMC	N/A	N/A	N/A	N/A
31	*Anechoic Chamber	Seo-Young EMC	N/A	N/A	N/A	N/A
32	*Shielded Room	Seo-Young EMC	N/A	N/A	N/A	N/A

*) Test equipment used during the test

10. ACCURACY OF MEASUREMENT

The Measurement Uncertainties stated were calculated in accordance with the requirements of measurement uncertainty contained in CISPR 16-4-2 with the confidence level of 95%

1. Conducted Uncertainty Calculation

Source of Uncertainty	Xi	Uncertainty of Xi		Coverage factor k	u(Xi) (dB)	Ci	Ci u(Xi) (dB)
		Value (dB)	Probability Distribution				
Receiver reading	***RI***	± 0.1	normal 1	1.000	0.1	1	0.1
Attenuation AMN-Receiver	***LC***	± 0.08	normal 2	2.000	0.04	1	0.04
AMN Voltage division factor	***LAMN***	± 0.8	normal 2	2.000	0.4	1	0.4
Sine wave voltage	***dVSW***	± 2.00	normal 2	2.000	1.00	1	1.00
Pulse amplitude response	***dVPA***	± 1.50	rectangular	1.732	0.87	1	0.87
Pulse repetition rate response	***dVPR***	± 1.50	rectangular	1.732	0.87	1	0.87
Noise floor proximity	***dVNF***	± 0.00	-	-	0.00	1	0.00
AMN Impedance	***dZ***	± 1.80	triangular	2.449	0.73	1	0.73
ⓐ Mismatch	***M***	+ 0.70	U-Shaped	1.414	0.49	1	0.49
ⓑ Mismatch	***M***	- 0.80	U-Shaped	1.414	- 0.56	1	- 0.56
Measurement System Repeatability	***RS***	0.05	normal 1	1.000	0.05	1	0.05
Remark	ⓐ: AMN-Receiver Mismatch : + ⓑ: AMN-Receiver Mismatch : -						
Combined Standard Uncertainty	Normal			± 1.88			
Expended Uncertainty U	Normal (k = 2)			± 3.76			

2. Radiation Uncertainty Calculation

Source of Uncertainty	Xi	Uncertainty of Xi		Coverage factor k	u(Xi) (dB)	Ci	Ci u(Xi) (dB)
		Value (dB)	Probability Distribution				
Receiver reading	***RI***	± 0.10	normal 1	1.000	0.10	1	0.10
Sine wave voltage	***dVsw***	± 2.00	normal 2	2.000	1.00	1	1.00
Pulse amplitude response	***dVpa***	± 1.50	rectangular	1.732	0.87	1	0.87
Pulse repetition rate response	***dVpr***	± 1.50	rectangular	1.732	0.87	1	0.87
Noise floor proximity	***dVnf***	± 0.50	normal 2	2.000	0.25	1	0.25
Antenna Factor Calibration	***AF***	± 1.50	normal 2	2.000	0.75	1	0.75
Attenuation Antenna-receiver	***CL***	± 0.52	normal 2	2.000	0.26	1	0.26
Antenna Directivity	***AD***	± 1.00	rectangular	1.732	0.58	1	0.58
Antenna Factor Height Dependence	***AH***	± 0.50	rectangular	1.732	0.29	1	0.29
Antenna Phase Centre Variation	***AP***	± 0.30	rectangular	1.732	0.17	1	0.17
Antenna Factor Frequency Interpolation	***AI***	± 0.30	rectangular	1.732	0.17	1	0.17
Site Imperfections	***SI***	± 4.00	triangular	2.449	1.63	1	1.63
Measurement Distance Variation	***DV***	± 0.10	rectangular	1.732	0.06	1	0.06
Antenna Balance	***Dbal***	± 0.90	rectangular	1.732	0.52	1	0.52
Cross Polarisation	***DCross***	± 0.90	rectangular	1.732	0.52	1	0.52
ⓐ Mismatch	***M***	+ 0.25	U-Shaped	1.414	0.18	1	0.18
ⓑ Mismatch	***M***	- 0.26	U-Shaped	1.414	- 0.18	1	- 0.18
ⓒ Mismatch	***M***	+ 0.98	U-Shaped	1.414	0.69	1	0.69
ⓓ Mismatch	***M***	- 1.11	U-Shaped	1.414	- 0.79	1	- 0.79
Measurement System Repeatability	***RS***	0.09	normal 1	1.000	0.09	1	0.09
Remark	ⓐ: Biconical Antenna-receiver Mismatch : + (< 200 MHz) ⓑ: Biconical Antenna-receiver Mismatch : - (< 200 MHz) ⓒ: Log Periodic Antenna-receiver Mismatch : + (≧ 200 MHz) ⓓ: Log Periodic Antenna-receiver Mismatch : - (≧ 200 MHz)						
Combined Standard Uncertainty	Normal			± 2.63 (< 200 MHz) ± 2.74 (≧200 MHz)			
Expended Uncertainty U	Normal (*k* = 2)			± 5.26 (< 200 MHz) ± 5.48 (≧200 MHz)			